



# EMC TEST REPORT

According to

EN 55022:2006/A1:2007 (Class A)  
AS/NZS CISPR 22:2009 (Class A)  
EN 61000-3-2 : 2009  
EN 61000-3-3 : 2008

EN 55024 : 1998/ A1:2001/ A2:2003  
IEC 61000-4-2 : 2008  
IEC 61000-4-3 : 2010  
IEC 61000-4-4 : 2010  
IEC 61000-4-5 : 2005  
IEC 61000-4-6 : 2008  
IEC 61000-4-8 : 2009  
IEC 61000-4-11 : 2004

Applicant : VIVOTEK INC.  
Address : 6F, No. 192, Lien-Cheng Rd., Chung-Ho,  
New Taipei City 235, Taiwan, R.O.C.  
Equipment : Outdoor Bullet Network Camera  
Model No. : IP8352  
Trade Name : VIVOTEK

Laboratory accreditation



- The test result refers exclusively to the test presented test model / sample.
- Without written approval of *CerpPASS Technology Corp.* the test report shall not be reproduced except in full.
- This test report is only applicable to European Community.



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# CERTIFICATE OF COMPLIANCE

According to

EN 55022:2006/A1:2007 (Class A)  
AS/NZS CISPR 22:2009 (Class A)  
EN 61000-3-2 : 2009  
EN 61000-3-3 : 2008

EN 55024 : 1998/ A1:2001/ A2:2003  
IEC 61000-4-2 : 2008  
IEC 61000-4-3 : 2010  
IEC 61000-4-4 : 2010  
IEC 61000-4-5 : 2005  
IEC 61000-4-6 : 2008  
IEC 61000-4-8 : 2009  
IEC 61000-4-11 : 2004

Applicant : VIVOTEK INC.

Address : 6F, No. 192, Lien-Cheng Rd., Chung-Ho,  
New Taipei City 235, Taiwan, R.O.C.

Equipment : Outdoor Bullet Network Camera

Model No. : IP8352

## I HEREBY CERTIFY THAT :

The measurements shown in this test report were made in accordance with the procedures given in **EUROPEAN COUNCIL DIRECTIVE 2004/108/EC**.

The equipment was **passed** the test performed according to **European Standard EN 55022:2006/A1:2007 (Class A), AS/NZS CISPR 22:2009 (Class A), EN61000-3-2: 2009, EN 61000-3-3:2008 and EN 55024:1998/ A1:2001/ A2:2003 (IEC 61000-4-2 : 2008, IEC 61000-4-3 : 2010, IEC 61000-4-4 : 2010, IEC 61000-4-5 : 2005, IEC 61000-4-6 : 2008, IEC 61000-4-8 : 2009, IEC 61000-4-11 : 2004 )**.

The test was carried out on Jul. 04, 2011 at **CerpPASS Technology Corp.**

Signature

Hill Chen  
EMC/RF B.U. Chief of Engineering Dept.



## 1. Declaration of Conformity and the CE Mark

There are three possible procedures pertaining to the declaration of conformity:

### 1.1. Conformity Testing and Declaration of Conformity by the Manufacturer or His Authorized Representative Established within the Community or by an Importer.

- Article 10 (1) of the EMC Directive, - § 3 (1) no. 2a of the EMC Act.

### 1.2. Declaration of Conformity Issued by the Manufacturer or His Authorized Representative Established within the Community or by an Importer Following Testing of the Product and Issued of an EC certificate of conformity by a competent body.

- Article 10 (2) of the EMC Directive, - § 3 (1) no. 2b of the EMC Act.

### 1.3. Declaration of Conformity Issued by the Manufacturer or His Authorized Representative Established within the Community or by an Importer Following Testing and Certification of the Product by a Notified Body.

- Article 10 (5) of the EMC Directive,  
- § 3 (1) no. 2b of the EMC Act (radio transmitting installations).

### 1.4. Specimen For The CE Marking Of Electrical / Electronical Equipment

The components of the CE marking shall have substantially the same vertical dimension, which may not be less than 5 mm.





## 2. Test Configuration of Equipment under Test

### 2.1. Feature of Equipment under Test

Please refer to user manual.

### 2.2. Test Manner

- a. During testing, the interface cables and equipment positions were varied according to Europe Standard EN55022 Class A.
- b. The complete test system included remote workstation, POE, AC Source and EUT for EMC test. The remote workstation included Notebook.
- c. The result of conduction test as follow:  
Test Mode 1. LINK LAN (1Gbps) + Live View, Power by adapter: 3A-183WP12  
Test Mode 2. LINK LAN (1Gbps) + Live View, Power by AC 24V Source: SD7151  
The "Test Mode 1" generated the worst test result, it was reported as final data.
- d. The result of disturbances at telecommunication ports test as follow:  
Test Mode 1. ISN LAN (10Mbps), Power by adapter: 3A-183WP12  
Test Mode 2. ISN LAN (100Mbps), Power by adapter: 3A-183WP12  
Test Mode 3. ISN LAN (1Gbps), Power by adapter: 3A-183WP12  
Test Mode 4. ISN LAN (10Mbps), Power by AC 24V Source: SD7151  
Test Mode 5. ISN LAN (100Mbps), Power by AC 24V Source: SD7151  
Test Mode 6. ISN LAN (1Gbps), Power by AC 24V Source: SD7151  
Test Mode 7. ISN LAN (10Mbps), Power by POE  
Test Mode 8. ISN LAN (100Mbps), Power by POE  
Test Mode 9. ISN LAN (1Gbps), Power by POE  
The "Test Mode 7~9" generated the worst test result, they were reported as final data.
- e. During the disturbances at telecommunication port test, the condition of LAN utilization in excess of 10%.
- f. The result of radiation test as follow:  
Test Mode 1. LINK LAN (1Gbps) + Live View, Power by adapter: 3A-183WP12  
Test Mode 2. LINK LAN (1Gbps) + Live View, Power by AC 24V Source: SD7151  
Test Mode 3. LINK LAN (1Gbps) + Live View, Power by POE  
For 30MHz~1GHz, "Test Mode 2" generated the worst test result, it was reported as final data.  
For 1GHz~6GHz, "Test Mode 3" generated the worst test result, it was reported as final data.
- g. The result of EMS test as follow:  
Test Mode 1. LINK LAN (1Gbps) + Live View, Power by adapter: 3A-183WP12  
Test Mode 2. LINK LAN (1Gbps) + Live View, Power by AC 24V Source: SD7151  
Test Mode 3. LINK LAN (1Gbps) + Live View, Power by POE
- h. An executive program, "PING.EXE" under WIN 7 was executed to transmit and receive data to the remote workstation through LAN.



### 2.3. Description of Support Unit

Device	Manufacturer	Model No.	Description
AC Source	VIVOTEK	SD7151	N/A
Remote Workstation			
Notebook	SONY	VPCEB25FW	Power Cable, Adapter Unshielding 1.8m
POE	NETGEAR	FS108P	N/A

Use Cable:

Cable	Quantity	Description
RJ45	1	Unshielding, 10.0m



## 2.4. General Information of Test

Test Site :	CerpPASS Technology Corp. 2F-11, No. 3, Yuan Qu St., (Nankang Software Park), Taipei, Taiwan 115, R.O.C.
Test Site Location (OATS2-SD) :	No.68-1, Shihbachongsi, Shihding Township, Taipei City 223, Taiwan, R.O.C.
FCC Registration Number :	TW1049, TW1061, 488071, 390316
IC Registration Number :	4934B-1, 4934D-1
VCCI Registration Number :	T-543 for Telecommunication Test C-3328 for Conducted emission test R-3013 for Radiated emission test G-97 for radiated disturbance above 1GHz
Test Voltage:	AC 230V/ 50Hz, AC 24V, POE
Test in Compliance with:	EMI Test (conduction and radiation) : EN 55022:2006/A1:2007 Class A AS/NZS CISPR 22:2009 Class A Harmonics Test : EN 61000-3-2:2009 Voltage Fluctuations Test : EN 61000-3-3:2008 EMS Test : EN 55024 :1998/ A1:2001/ A2:2003 ESD : IEC 61000-4-2 : 2008 RS : IEC 61000-4-3 : 2010 EFT : IEC 61000-4-4 : 2010 SURGE : IEC 61000-4-5 : 2005 CS : IEC 61000-4-6 : 2008 Power Frequency Magnetic Field : IEC 61000-4-8 : 2009 DIPS : IEC 61000-4-11 : 2004
Frequency Range Investigated :	Conducted Emission Test: from 150kHz to 30 MHz Radiated Emission Test: from 30 MHz to 6,000 MHz
Test Distance :	The test distance of radiated emission below 1GHz from antenna to EUT is 10 M. The test distance of radiated emission above 1GHz from antenna to EUT is 3 M.

## 2.5. Measurement Uncertainty

Measurement Item	Measurement Frequency	Polarization	Uncertainty
Conducted Emission	9 kHz ~ 30 MHz	LINE / NEUTRAL	2.71dB
Radiated Emission	30 MHz ~ 1,000 MHz	Vertical	3.52 dB
		Horizontal	3.39 dB
	1,000 MHz ~ 18,000 MHz	Vertical	4.39 dB
		Horizontal	5.25 dB





**2.6. History of this test report**

■ ORIGINAL.

Additional attachment as following record:

Attachment No.	Issue Date	Description



### 3. Test of Conducted Emission

#### 3.1. Test Limit

Conducted Emissions were measured from 150 kHz to 30 MHz with a bandwidth of 9 kHz and return leads of the EUT according to the methods defined in European Standard EN 55022. The EUT was placed on a nonmetallic stand in a shielded room 0.8 meters above the ground plane as shown in section 4.2. The interface cables and equipment positioning were varied within limits of reasonable applications to determine the position producing maximum conducted emissions.

**Table 1 Class A Line Conducted Emission Limits:**

Frequency range (MHz)	Limits (dB $\mu$ V)	
	Quasi Peak	Average
0.15 to 0.50	79	66
0.50 to 30	73	60

Note : The lower limits shall apply at the transition frequencies.

**Table 2 - Limits of conducted common mode (asymmetric mode) disturbance at telecommunication ports in the frequency range 0.15 MHz to 30 MHz for class A equipment.**

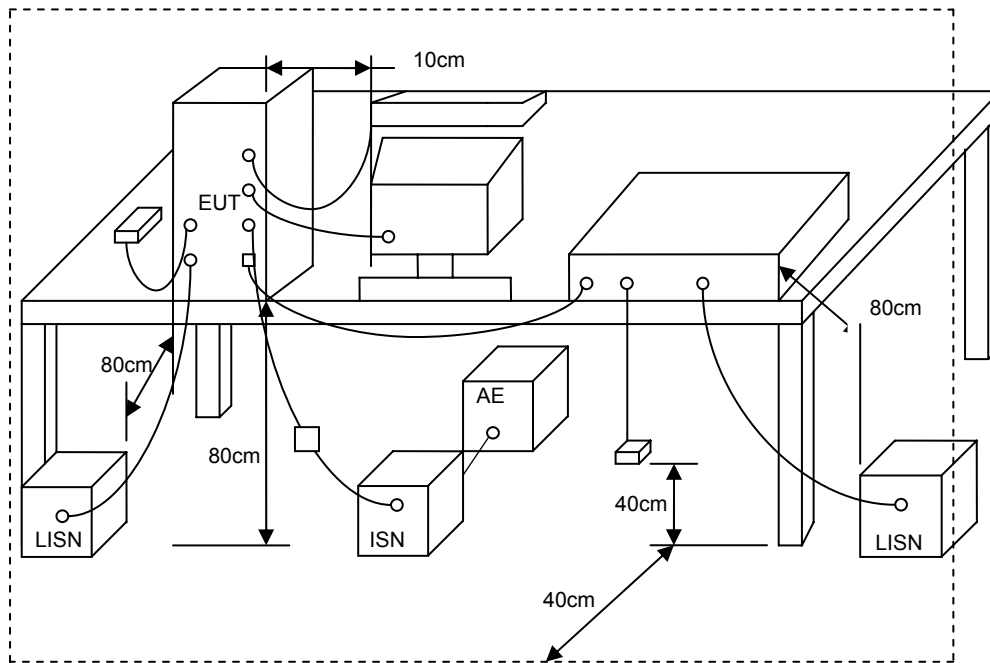
Frequency range (MHz)	Voltage limits dB( $\mu$ V)		Current limits dB( $\mu$ A)	
	Quasi-peak	Average	Quasi-peak	Average
0.15 to 0.5	97 to 87	84 to 74	53 to 43	40 to 30
0.5 to 30	87	74	43	30

Note 1: The limits decrease linearly with the logarithm of the frequency in the range 0.15 to 0.5 MHz.  
 Note 2 : The current and voltage disturbance limits are derived for use with an impedance stabilization network (ISN) which presents a common mode (asymmetric mode) impedance of 150  $\Omega$  to the telecommunication under test (conversion factor is  $20 \log_{10} 150/1 = 44\text{dB}$ ).

### 3.2. Test Procedures

- a. The EUT was placed on a desk 0.8 meters height from the metal ground plane and 0.4 meter from the conducting wall of the shielding room and it was kept at least 0.8 meters from any other grounded conducting surface.
- b. Connect EUT to the power mains through a line impedance stabilization network (LISN).
- c. All the support units are connecting to the other LISN.
- d. The LISN provides 50 ohm coupling impedance for the measuring instrument.
- e. The CISPR states that a 50 ohm, 50 micro-Henry LISN should be used.
- f. Both sides of AC line were checked for maximum conducted interference.
- g. The frequency range from 150 kHz to 30 MHz was searched
- h. Set the test-receiver system to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.

### 3.3. Typical Test Setup



### 3.4. Measurement Equipment

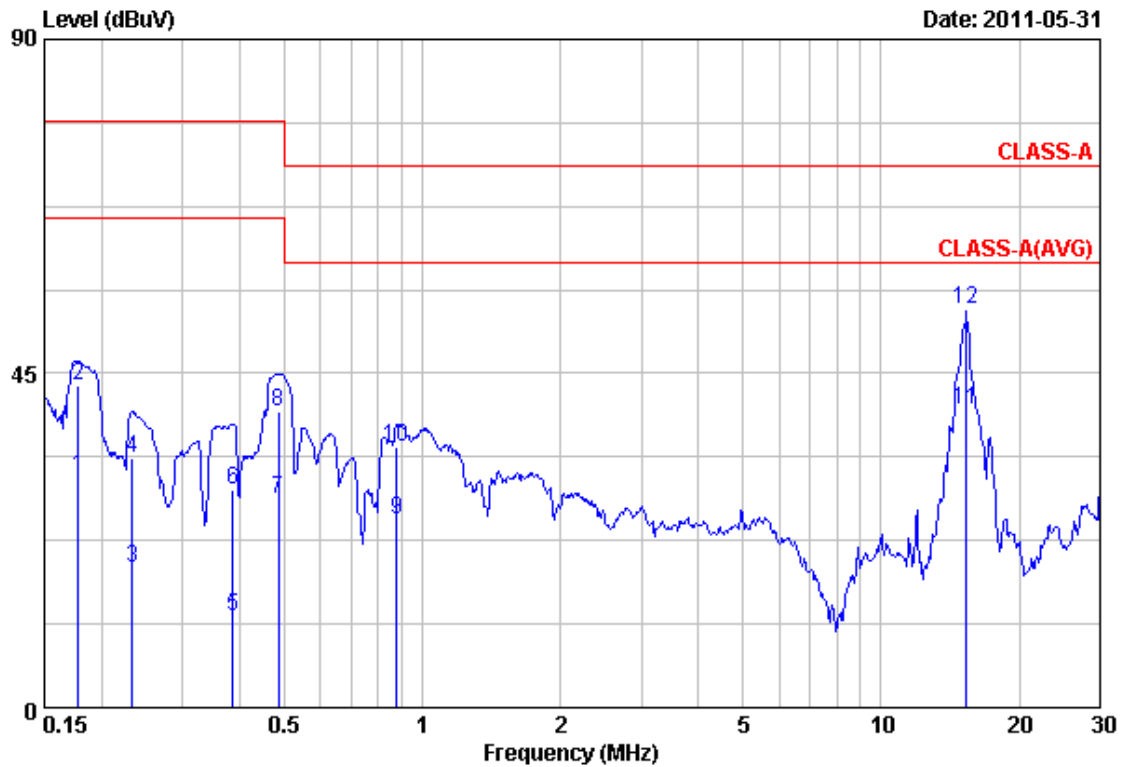
Instrument	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date
EMI Receiver	R&S	ESCI	100443	2011/02/08	2012/02/07
LISN	Schwarzbeck	NSLK 8127	8127-516	2011/05/05	2012/05/04
LISN	MessTec	NNS-2/16L	02/10191	2010/07/19	2011/07/18
ISN	TESEQ GMBH	ISN T8	24315	2010/06/18	2011/06/17



### 3.5. Test Result and Data

#### 3.5.1 Conducted Emission for Power Port Test Data

Power	: AC 230V	Pol/Phase	: LINE
Test Mode 1	: LINK LAN (1Gbps) + Live View	Temperature	: 24 °C
Memo	: Power by adapter: 3A-183WP12	Humidity	: 62 %

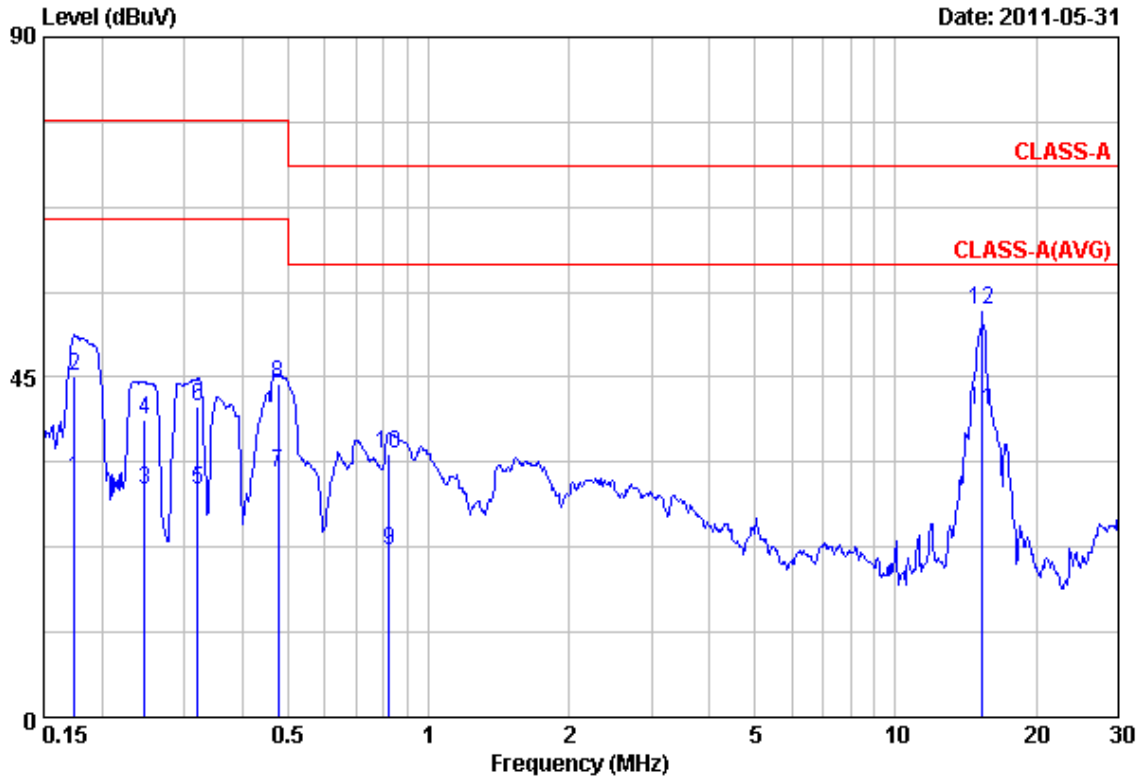


Item	Freq MHz	Read Value dBuV	Factor dB	Result dBuV	Limit dBuV	Margin dBuV	Remark
1	0.178	31.020	0.080	31.100	66.000	-34.900	Average
2	0.178	43.300	0.080	43.380	79.000	-35.620	QP
3	0.233	18.816	0.080	18.896	66.000	-47.104	Average
4	0.233	33.624	0.080	33.704	79.000	-45.296	QP
5	0.387	12.221	0.080	12.301	66.000	-53.699	Average
6	0.387	29.146	0.080	29.226	79.000	-49.774	QP
7	0.486	27.896	0.084	27.980	66.000	-38.020	Average
8	0.486	39.706	0.084	39.790	79.000	-39.210	QP
9	0.880	25.208	0.104	25.312	60.000	-34.688	Average
10	0.880	34.892	0.104	34.996	73.000	-38.004	QP
11	15.307	39.714	0.495	40.209	60.000	-19.791	Average
12	15.307	53.094	0.495	53.589	73.000	-19.411	QP

Remarks: 1. Result = Read Value + Factor  
2. Factor = LISN(ISN) Factor + Cable Loss



Power	: AC 230V	Pol/Phase	: NEUTRAL
Test Mode 1	: LINK LAN (1Gbps) + Live View	Temperature	: 24 °C
Memo	: Power by adapter: 3A-183WP12	Humidity	: 62 %



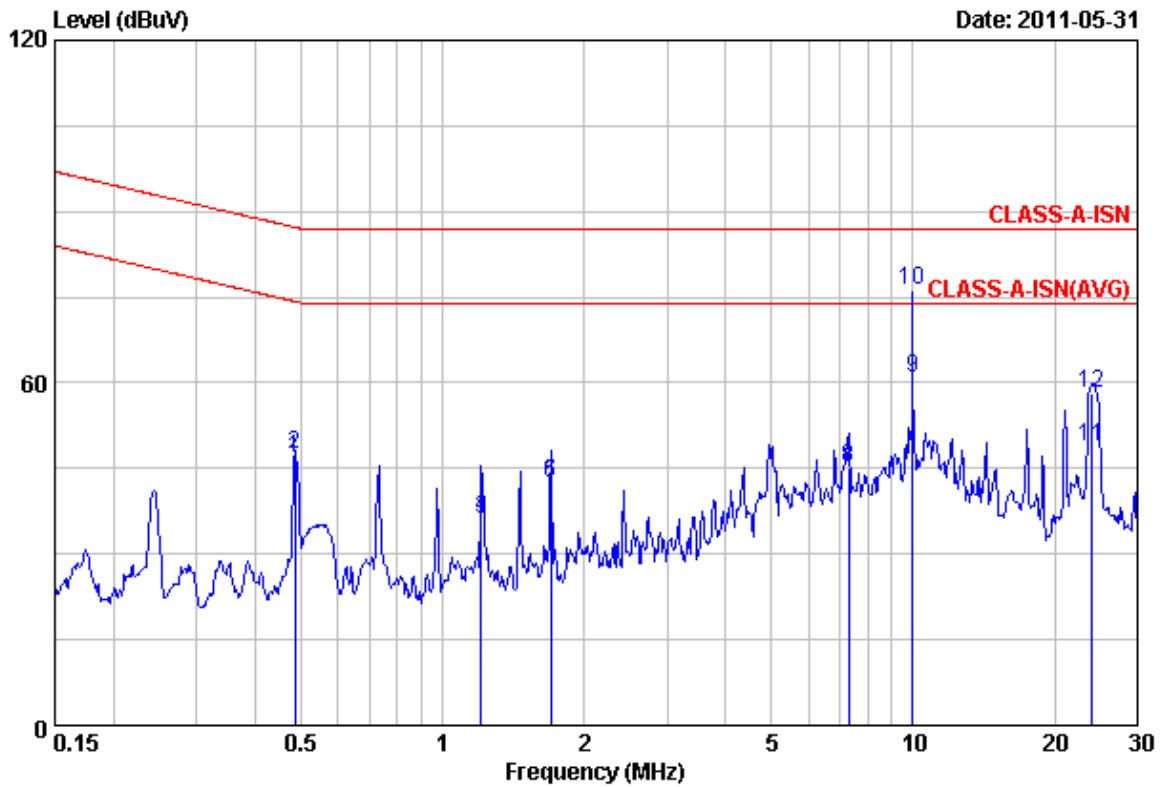
Item	Freq	Read Value	Factor	Result	Limit	Margin	Remark
	MHz	dBuV	dB	dBuV	dBuV	dBuV	
1	0.175	31.578	0.061	31.639	66.000	-34.361	Average
2	0.175	45.042	0.061	45.103	79.000	-33.897	QP
3	0.247	30.103	0.062	30.165	66.000	-35.835	Average
4	0.247	39.312	0.062	39.374	79.000	-39.626	QP
5	0.320	30.074	0.064	30.138	66.000	-35.862	Average
6	0.320	40.985	0.064	41.049	79.000	-37.951	QP
7	0.476	32.207	0.068	32.275	66.000	-33.725	Average
8	0.476	43.940	0.068	44.008	79.000	-34.992	QP
9	0.822	21.972	0.076	22.048	60.000	-37.952	Average
10	0.822	34.790	0.076	34.866	73.000	-38.134	QP
11	15.307	40.346	0.329	40.675	60.000	-19.325	Average
12	15.307	53.614	0.329	53.943	73.000	-19.057	QP

Remarks: 1. Result = Read Value + Factor  
2. Factor = LISN(ISN) Factor + Cable Loss



3.5.2 Conducted Emission for Telecommunication Port Test Data

Power	: POE	Temperature	: 24 °C
Test Mode 7	: ISN LAN (10Mbps)	Humidity	: 62 %
Memo	: Power by POE		

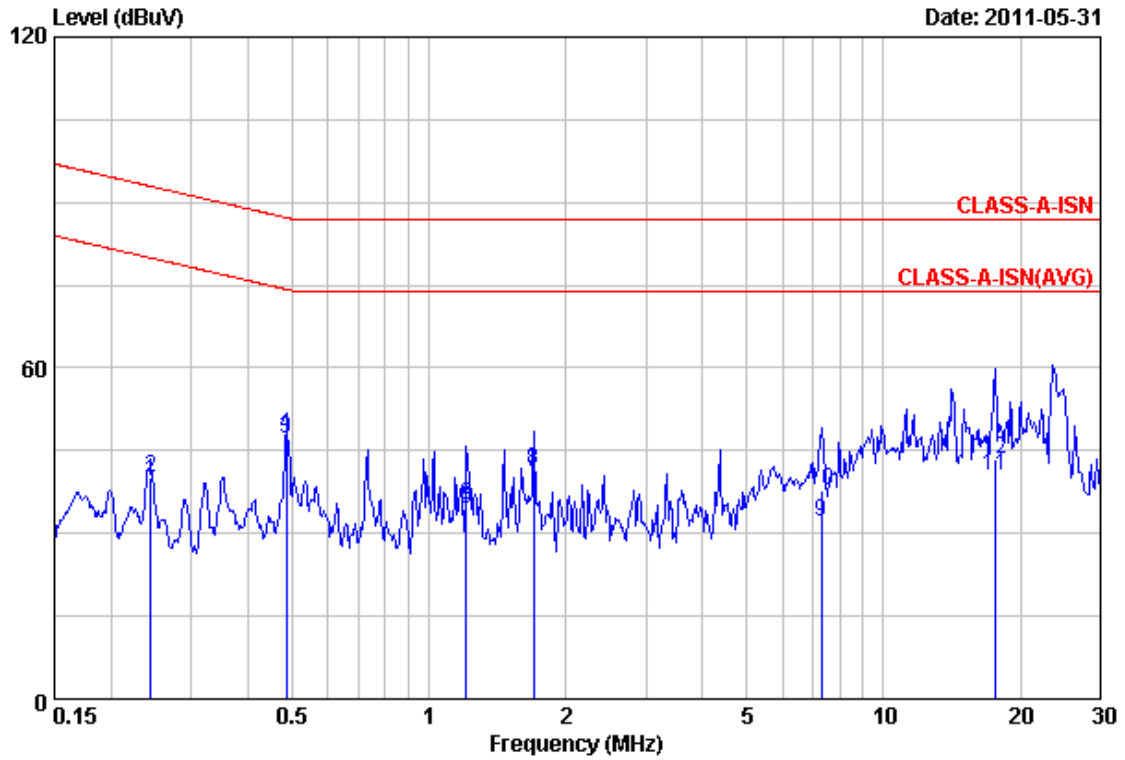


Item	Freq MHz	Read Value dBuV	Factor dB	Result dBuV	Limit dBuV	Margin dBuV	Remark
1	0.486	36.964	9.977	46.941	74.230	-27.289	Average
2	0.486	37.623	9.977	47.600	87.230	-39.630	QP
3	1.210	25.969	10.028	35.997	74.000	-38.003	Average
4	1.210	26.250	10.028	36.278	87.000	-50.722	QP
5	1.698	32.281	10.048	42.329	74.000	-31.671	Average
6	1.698	32.454	10.048	42.502	87.000	-44.498	QP
7	7.296	34.409	10.183	44.592	74.000	-29.408	Average
8	7.296	34.836	10.183	45.019	87.000	-41.981	QP
9	10.000	50.727	10.270	60.997	74.000	-13.003	Average
10	10.000	65.779	10.270	76.049	87.000	-10.951	QP
11	23.888	38.605	10.238	48.843	74.000	-25.157	Average
12	23.888	48.064	10.238	58.302	87.000	-28.698	QP

Remarks: 1. Result = Read Value + Factor  
2. Factor = LISN(ISN) Factor + Cable Loss



Power	: POE	Temperature	: 24 °C
Test Mode 8	: ISN LAN (100Mbps)	Humidity	: 62 %
Memo	: Power by POE		

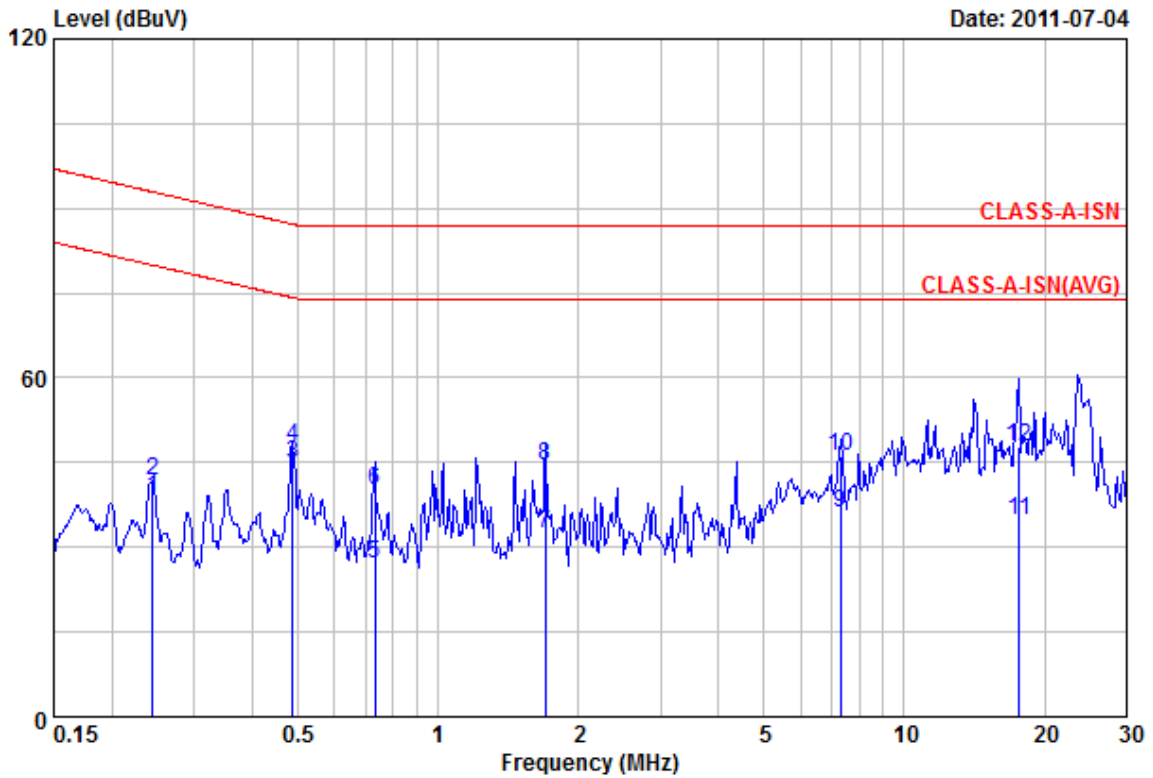


Item	Freq	Read Value	Factor	Result	Limit	Margin	Remark
	MHz	dBuV	dB	dBuV	dBuV	dBuV	
1	0.244	29.500	9.920	39.420	79.951	-40.531	Average
2	0.244	30.324	9.920	40.244	92.951	-52.707	QP
3	0.486	36.996	9.977	46.973	74.230	-27.257	Average
4	0.486	37.701	9.977	47.678	87.230	-39.552	QP
5	1.210	24.283	10.028	34.311	74.000	-39.689	Average
6	1.210	25.212	10.028	35.240	87.000	-51.760	QP
7	1.698	31.034	10.048	41.082	74.000	-32.918	Average
8	1.698	31.447	10.048	41.495	87.000	-45.505	QP
9	7.290	21.831	10.183	32.014	74.000	-41.986	Average
10	7.290	27.543	10.183	37.726	87.000	-49.274	QP
11	17.661	30.213	10.186	40.399	74.000	-33.601	Average
12	17.661	33.192	10.186	43.378	87.000	-43.622	QP

Remarks: 1. Result = Read Value + Factor  
2. Factor = LISN(ISN) Factor + Cable Loss



Power	: POE	Temperature	: 24 °C
Test Mode 9	: ISN LAN (1Gbps)	Humidity	: 62 %
Memo	: Power by POE		



Item	Freq	Read Value	Factor	Result	Limit	Margin	Remark
	MHz	dBuV	dB	dBuV	dBuV	dBuV	
1	0.244	28.987	9.920	38.907	79.951	-41.044	Average
2	0.244	31.987	9.920	41.907	92.951	-51.044	QP
3	0.489	34.826	9.977	44.803	74.186	-29.383	Average
4	0.489	37.826	9.977	47.803	87.186	-39.383	QP
5	0.731	17.205	9.999	27.204	74.000	-46.796	Average
6	0.731	30.205	9.999	40.204	87.000	-46.796	QP
7	1.698	22.384	10.048	32.432	74.000	-41.568	Average
8	1.698	34.384	10.048	44.432	87.000	-42.568	QP
9	7.290	25.874	10.183	36.057	74.000	-37.943	Average
10	7.290	35.874	10.183	46.057	87.000	-40.943	QP
11	17.661	24.722	10.186	34.908	74.000	-39.092	Average
12	17.661	37.722	10.186	47.908	87.000	-39.092	QP

Remarks: 1. Result = Read Value + Factor  
 2. Factor = LISN(ISN) Factor + Cable Loss

Test engineer: Dean





### 3.6. Test Photographs of Power Port

Front View



Rear View





### 3.7. Test Photographs of Telecommunication Port

Rear View





## 4. Test of Radiated Emission

### 4.1. Test Limit

The EUT shall meet the limits of below Table when measured at the measuring distance R in accordance with the methods described in European Standard EN 55022 Clause 10. If the reading on the measuring receiver shows fluctuations close to the limit, the reading shall be observed for at least 15 s at each measurement frequency; the highest reading shall be recorded, with the exception of any brief isolated high reading, which shall be ignored.

Table – Limits for radiated disturbance of class A ITE at a measuring distance of 10 m

Frequency range MHz	Quasi-peak limits dB( $\mu$ V/m)
30 to 230	40
230 to 1000	47

NOTE 1 The lower limit shall apply at the transition frequency.  
NOTE 2 Additional provisions may be required for cases where interference occurs.

The EUT shall meet the limits of below Table when measured in accordance with the method described in European Standard EN 55022 Clause 10 and the conditional testing procedure described below.

Table – Limits for radiated disturbance of class A ITE at a measuring distance of 3 m

Frequency range GHz	Average limit dB( $\mu$ V/m)	Peak limits dB( $\mu$ V/m)
1 to 3	56	76
3 to 6	60	80

NOTE The lower limit applies at the transition frequency.

#### • Conditional testing procedure:

The highest internal source of an EUT is defined as the highest frequency generated or used within the EUT or on which the EUT operates or tunes.

If the highest frequency of the internal sources of the EUT is less than 108 MHz, the measurement shall only be made up to 1 GHz.

If the highest frequency of the internal sources of the EUT is between 108 MHz and 500 MHz, the measurement shall only be made up to 2 GHz.

If the highest frequency of the internal sources of the EUT is between 500 MHz and 1 GHz, the measurement shall only be made up to 5 GHz.

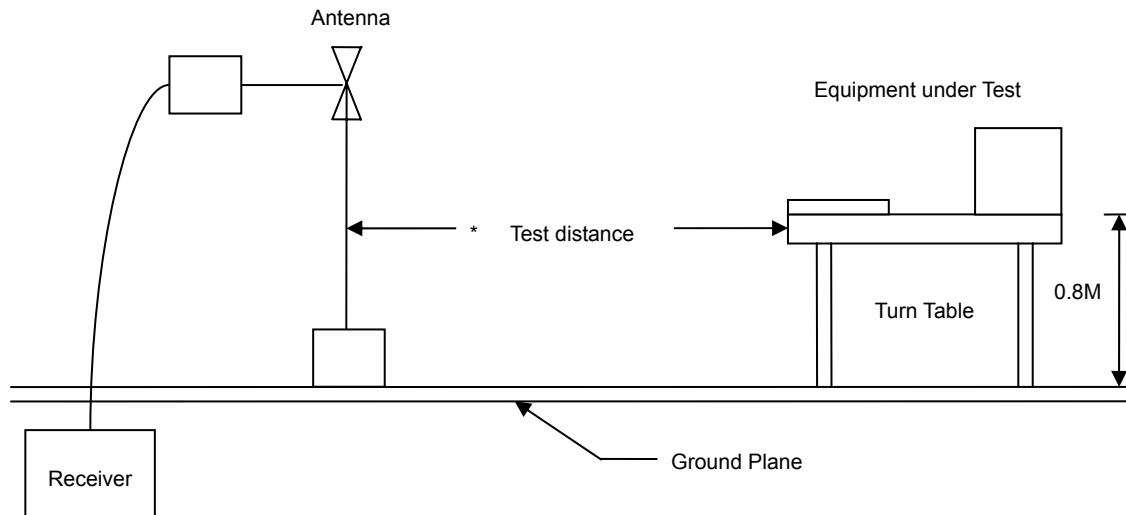
If the highest frequency of the internal sources of the EUT is above 1 GHz, the measurement shall be made up to 5 times the highest frequency or 6 GHz, whichever is less.



## 4.2. Test Procedures

- a. The EUT was placed on a rotatable table top 0.8 meter above ground.
- b. The EUT was set 3/10 meters from the interference receiving antenna which was mounted on the top of a variable height antenna tower.
- c. The table was rotated 360 degrees to determine the position of the highest radiation.
- d. The antenna is a half wave dipole and its height is varied between one meter and four meters above ground to find the maximum value of the field strength both horizontal polarization and vertical polarization of the antenna are set to make the measurement.
- e. For each suspected emission the EUT was arranged to its worst case and then tune the antenna tower (from 1 M to 4 M) and turn table (from 0 degree to 360 degrees) to find the maximum reading.
- f. Set the test-receiver system to Peak Detect Function and specified bandwidth with Maximum Hold Mode.
- g. If the emission level of the EUT in peak mode was 3 dB lower than the limit specified, then testing will be stopped and peak values of EUT will be reported, otherwise, the emissions which do not have 3 dB margin will be repeated one by one using the quasi-peak method and reported.

### 4.3. Typical Test Setup



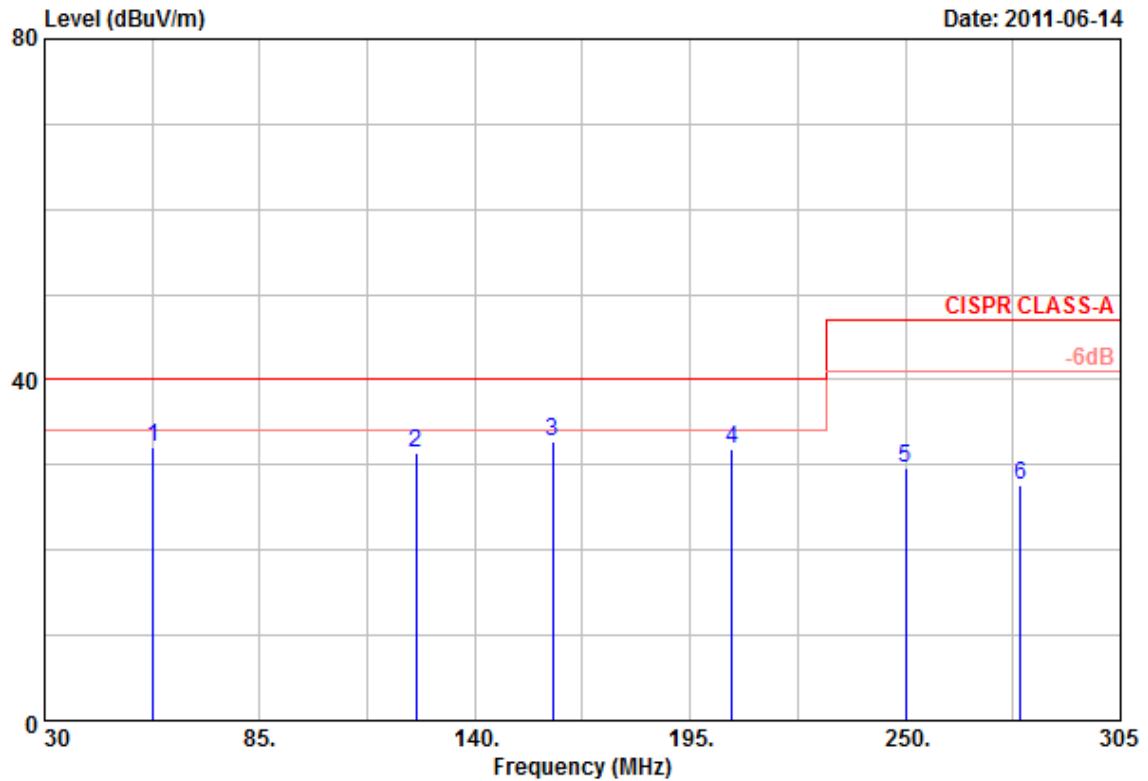
### 4.4. Measurement Equipment

Instrument	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date
Bilog Antenna	Schaffner	CBL6112B	2840	2011/05/06	2012/05/05
Amplifier	Agilent	8447D	2944A10593	2011/05/03	2012/05/02
Signal Generator	HP	8648B	3629U00612	2011/01/24	2012/01/23
EMI Receiver	SCHAFFNER	SCR3501	437	2010/10/14	2011/10/13
Spectrum Analyzer	R&S	FSP 3	100800	2011/03/02	2012/03/01
Spectrum Analyzer	R&S	FSP40	100219	2010/11/05	2011/11/04
Horn Antenna	EMCO	3115	31589	2011/05/02	2012/05/01
Preamplifier	Agilent	8449B	3008A01954	2011/03/02	2012/03/01



### 4.5. Test Result and Data (30MHz~1GHz)

Power	: AC 24V	Pol/Phase	: VERTICAL
Test Mode 2	: LINK LAN (1Gbps) + Live View	Temperature	: 30 °C
Memo	: Power by AC 24V Source: SD7151	Humidity	: 68 %

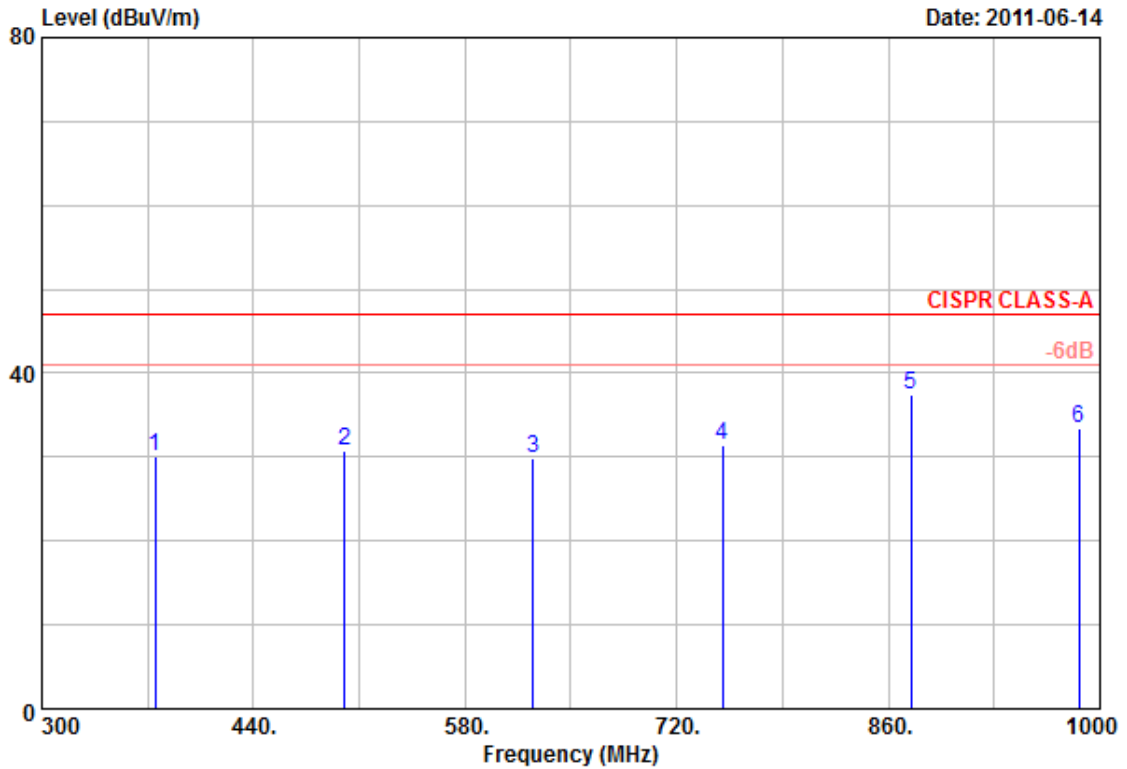


Item	Freq	Read Value	Factor	Result	Limit	Margin	Remark	Ant Pos	Tab Pos
	MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB		cm	Deg
1	57.775	51.082	-18.978	32.104	40.000	-7.896	QP	400	0
2	125.000	42.330	-10.990	31.340	40.000	-8.660	QP	400	0
3	159.800	43.697	-10.864	32.833	40.000	-7.167	QP	400	0
4	205.725	42.497	-10.698	31.799	40.000	-8.201	QP	400	0
5	250.000	41.556	-11.860	29.696	47.000	-17.304	QP	400	0
6	279.425	34.975	-7.340	27.635	47.000	-19.365	QP	400	0

Remarks: 1. Result = Read Value + Factor  
 2. Factor = Antenna factor + Cable loss - Amplifier factor



Power	: AC 24V	Pol/Phase	: VERTICAL
Test Mode 2	: LINK LAN (1Gbps) + Live View	Temperature	: 30 °C
Memo	: Power by AC 24V Source: SD7151	Humidity	: 68 %

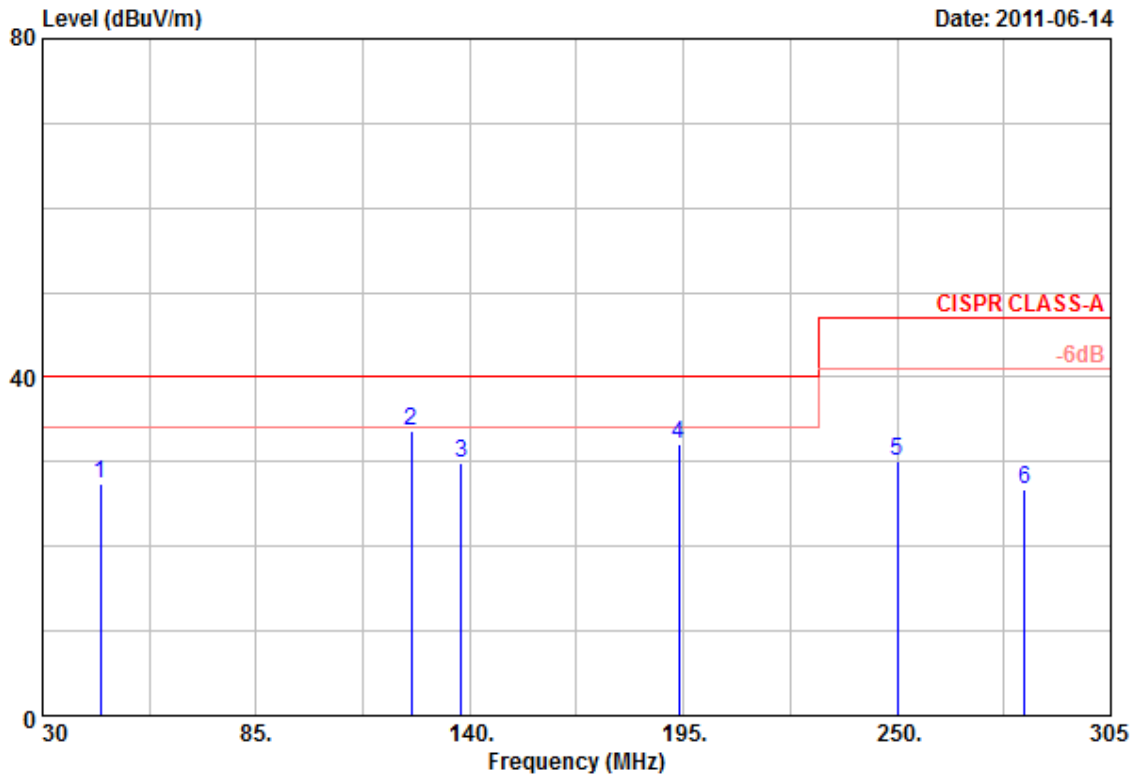


Item	Freq	Read Value	Factor	Result	Limit	Margin	Remark	Ant Pos	Tab Pos
	MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB		cm	Deg
1	375.000	38.887	-8.700	30.187	47.000	-16.813	QP	100	0
2	500.000	35.161	-4.400	30.761	47.000	-16.239	QP	100	0
3	625.000	31.618	-1.725	29.893	47.000	-17.107	QP	100	0
4	750.000	30.897	0.610	31.507	47.000	-15.493	QP	100	0
5	875.000	31.636	5.715	37.351	47.000	-9.649	QP	100	0
6	986.000	25.502	7.916	33.418	47.000	-13.582	QP	100	0

Remarks: 1. Result = Read Value + Factor  
 2. Factor = Antenna factor + Cable loss - Amplifier factor



Power	: AC 24V	Pol/Phase	: HORIZONTAL
Test Mode 2	: LINK LAN (1Gbps) + Live View	Temperature	: 30 °C
Memo	: Power by AC 24V Source: SD7151	Humidity	: 68 %



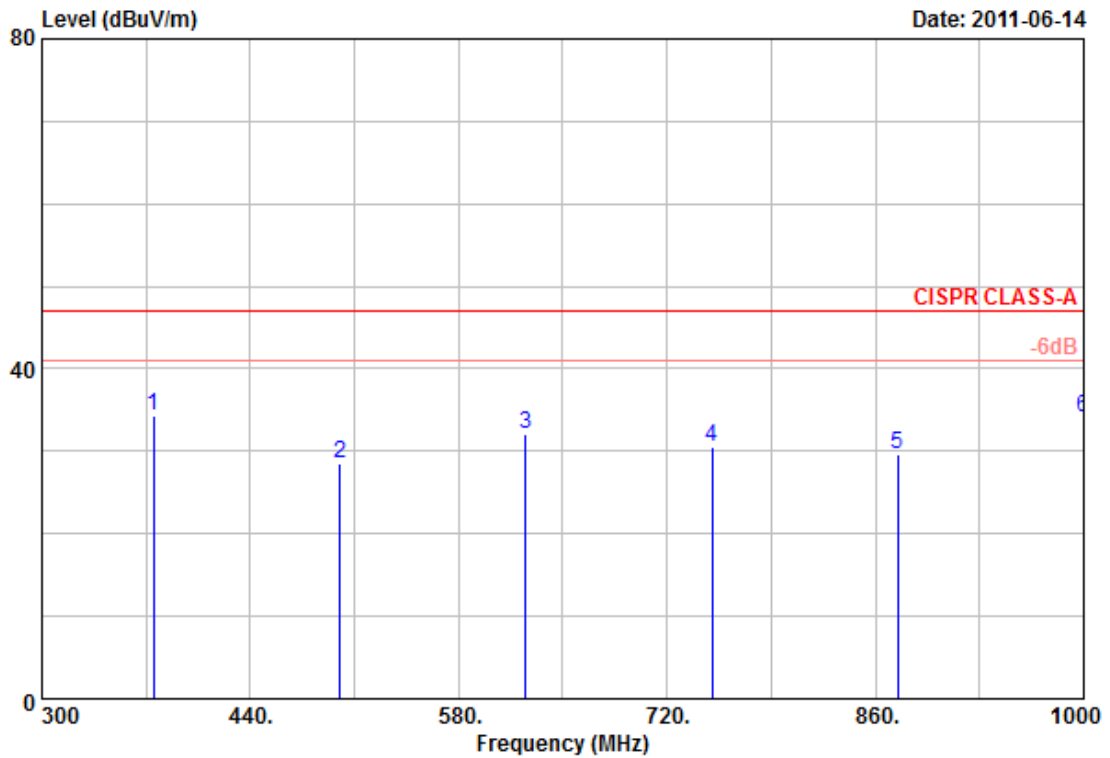
Item	Freq	Read Value	Factor	Result	Limit	Margin	Remark	Ant Pos	Tab Pos
	MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB		cm	Deg
1	44.850	45.650	-18.325	27.325	40.000	-12.675	QP	400	0
2	125.000	46.321	-12.610	33.711	40.000	-6.289	QP	400	0
3	137.800	42.771	-12.876	29.895	40.000	-10.105	QP	400	0
4	193.900	46.102	-13.943	32.159	40.000	-7.841	QP	400	0
5	250.000	41.555	-11.490	30.065	47.000	-16.935	QP	400	0
6	282.725	37.244	-10.523	26.721	47.000	-20.279	QP	400	0

Remarks: 1. Result = Read Value + Factor  
 2. Factor = Antenna factor + Cable loss - Amplifier factor





Power	: AC 24V	Pol/Phase	: HORIZONTAL
Test Mode 2	: LINK LAN (1Gbps) + Live View	Temperature	: 30 °C
Memo	: Power by AC 24V Source: SD7151	Humidity	: 68 %



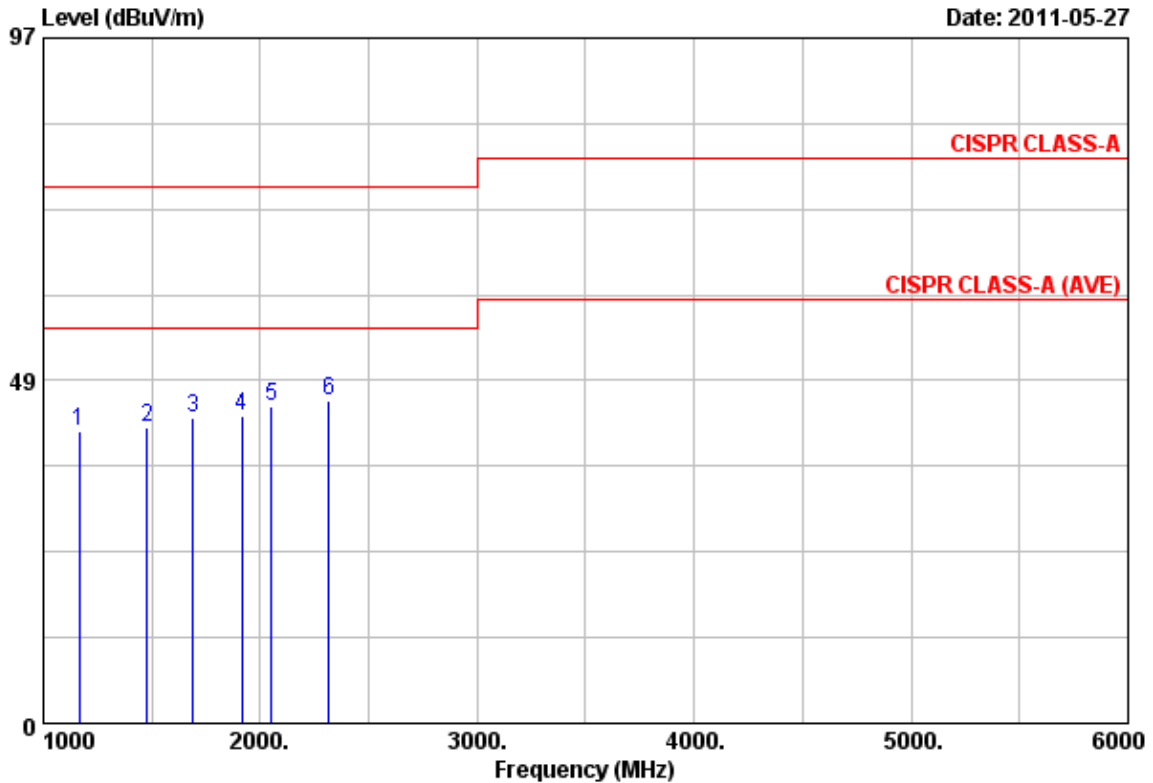
Item	Freq	Read Value	Factor	Result	Limit	Margin	Remark	Ant Pos	Tab Pos
	MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB		cm	Deg
1	375.000	38.745	-4.510	34.235	47.000	-12.765	QP	100	0
2	500.000	34.761	-6.230	28.531	47.000	-18.469	QP	100	0
3	625.000	32.330	-0.165	32.165	47.000	-14.835	QP	100	0
4	750.000	29.668	0.830	30.498	47.000	-16.502	QP	100	0
5	875.000	25.746	3.955	29.701	47.000	-17.299	QP	100	0
6	1000.000	25.548	8.520	34.068	47.000	-12.932	QP	100	0

Remarks: 1. Result = Read Value + Factor  
 2. Factor = Antenna factor + Cable loss - Amplifier factor



### 4.6. Test Result and Data (1GHz~6GHz)

Power	: POE	Pol/Phase	: VERTICAL
Test Mode 3	: LINK LAN (1Gbps) + Live View	Temperature	: 26 °C
Memo	: Power by POE	Humidity	: 69 %

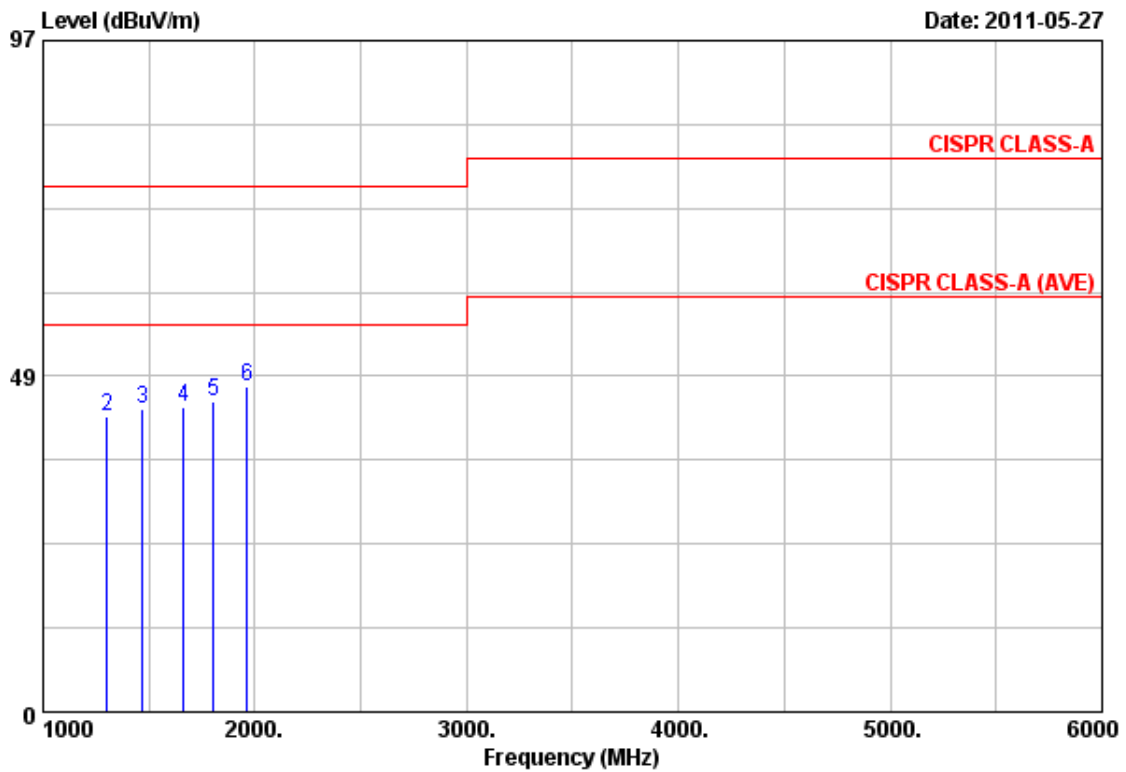


Item	Freq	Read Value	Factor	Result	Limit	Margin	Remark	Ant Pos	Tab Pos
	MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB		cm	Deg
1	1165.00	49.66	-8.38	41.28	76.00	-34.72	Peak	100	0
2	1480.00	48.52	-6.55	41.97	76.00	-34.03	Peak	100	0
3	1690.00	48.49	-5.24	43.25	76.00	-32.75	Peak	100	0
4	1915.00	47.30	-3.82	43.48	76.00	-32.52	Peak	100	0
5	2050.00	47.89	-3.13	44.76	76.00	-31.24	Peak	100	0
6	2315.00	47.92	-2.24	45.68	76.00	-30.32	Peak	100	0

Remarks: 1. Result = Read Value + Factor  
 2. Factor = Antenna factor + Cable loss - Amplifier factor



Power	: POE	Pol/Phase	: HORIZONTAL
Test Mode 3	: LINK LAN (1Gbps) + Live View	Temperature	: 26 °C
Memo	: Power by POE	Humidity	: 69 %



Item	Freq MHz	Read Value dBuV	Factor dB/m	Result dBuV/m	Limit dBuV/m	Margin dB	Remark	Ant Pos cm	Tab Pos Deg
1	1000.10	51.46	-9.35	42.11	76.00	-33.89	Peak	100	360
2	1300.00	50.16	-7.60	42.56	76.00	-33.44	Peak	100	360
3	1470.00	50.38	-6.60	43.78	76.00	-32.22	Peak	100	360
4	1665.00	49.56	-5.39	44.17	76.00	-31.83	Peak	100	360
5	1805.00	49.35	-4.52	44.83	76.00	-31.17	Peak	100	360
6	1965.00	50.48	-3.52	46.96	76.00	-29.04	Peak	100	360

Remarks: 1. Result = Read Value + Factor  
 2. Factor = Antenna factor + Cable loss - Amplifier factor

Test engineer: Karp



#### 4.7. Test Photographs

Front View



Rear View





## 5. Harmonics Test

### 5.1. Limits of Harmonics Current Measurement

Limits for Class A equipment		Limits for Class D equipment		
Harmonics Order n	Max. Permissible harmonics current A	Harmonics Order n	Max. Permissible harmonics current per watt mA/W	Max. Permissible harmonics current A
Odd harmonics		Odd Harmonics only		
3	2.30	3	3.4	2.30
5	1.14	5	1.9	1.14
7	0.77	7	1.0	0.77
9	0.40	9	0.5	0.40
11	0.33	11	0.35	0.33
13	0.21	13	0.30	0.21
15<=n<=39	0.15 x 15/n	15<=n<=39	3.85/n	0.15 x 15/n
Even harmonics				
2	1.08			
4	0.43			
6	0.30			
8<=n<=40	0.23 x 8/n			

**NOTE:**

1. Class A and Class D are classified according to item section 5 of EN 61000-3-2 : 2006/A1:2009/A2:2009.
2. According go section 7 of EN 61000-3-2 : 2006/A1:2009/A2:2009, the above limits for all equipment except for lighting equipment are for all applications having an active input power > 75 W and no limits apply for equipment with an active input power up to and including 75 W.

### 5.2. Test Result and Data

As specified on clause 7 and figure Z1 of EN 61000-3-2 : 2006/A1:2009/A2:2009, the limits are not specified for equipment with a rated power of 75W or less.

The EUT meets the above condition, so it conforms to EN 61000-3-2.



## 6. Voltage Fluctuations Test

### 6.1. Test Procedure

The equipment shall be tested under the conditions of **Clause 5**.

The total impedance of the test circuit, excluding the appliance under test, but including the internal impedance of the supply source, shall be equal to the reference impedance. The stability and tolerance of the reference impedance shall be adequate to ensure that the overall accuracy of  $\pm 8\%$  is achieved during the whole assessment procedure.

### 6.2. Measurement Equipment

Instrument	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date
Power & Harmonics Analyzer	TTI	HA1600	198226	2010/12/28	2011/12/27



6.3. Test Result and Data

Basic Standard : EN 61000-3-3 Temperature : 24
Final Test Result : PASS Relative Humidity : 57 %
Test Data : Jun. 03, 2011

Supply Voltage: 230.7 to 230.7 Vrms 328.3 Vpk Frequency: 50.00 Hz
THD: 0.5% Crest Factor: 1.423 peak at: 93.6 deg

Load Power: 0.004 kW 0.019 kVA Power Factor: 0.347

Load Current: 0.06 to 0.08 Arms 0.39 Apk Crest Factor: 4.994

Voltage Variations

Highest Half-cycle level: +1.12%
Lowest Half-cycle level: +0.15%
d(max): 0.97% Pass

Number of Change Intervals: 3
Highest d(t) for 500 ms: 0.00% Pass
Longest d(t) over 3.30%: 0.02 seconds

'Steady State' definition: >1000 ms below 0.32%
Highest Steady State level: 0.30%
Lowest Steady State level: 0.27%
max d(c) between adjacent: 0.03% Pass
max d(c) between any: 0.03%

Flicker

Long-term Flicker indicator Plt : 0.00

Short-term Flicker indicator Pst :

Table with 2 columns: Plt Interval, Pst. Values range from 1: 0.06 to 12: 0.06.

Table with 3 columns: Pst classifier, Duration, Flicker. Lists various Pst values and their corresponding durations.

Test engineer: Dora



### 6.4. Test Photographs

Front View



Rear View





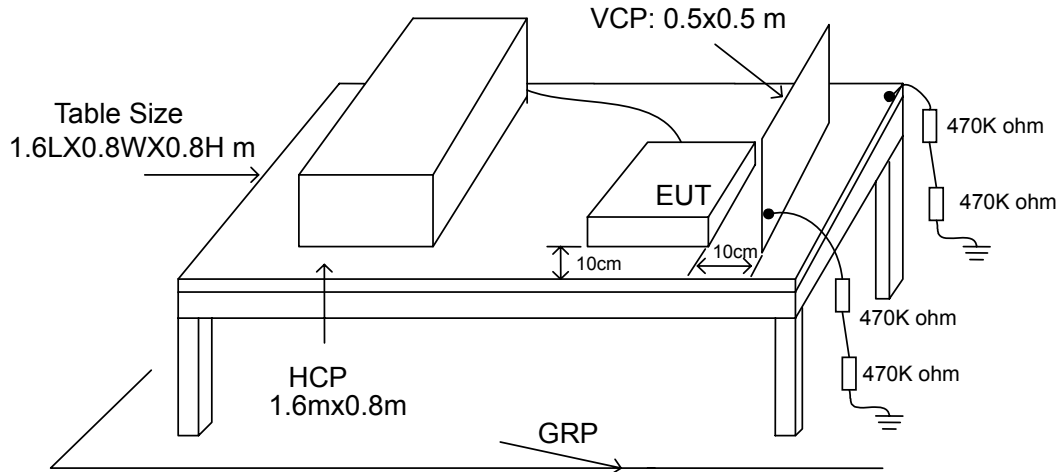


## 7. Electrostatic Discharge Immunity Test

### 7.1. Test Procedure

- a. In the case of air discharge testing the climatic conditions shall be within the following ranges:
  - ambient temperature: 15 to 35 ;
  - relative humidity : 30% to 60%;
  - atmospheric pressure : 86 KPa (860 mbar) to 106 KPa (1060 mbar).
- b. Test programs and software shall be chosen so as to exercise all normal modes of operation of the EUT. The use of special exercising software is encouraged, but permitted only where it can be shown that the EUT is being comprehensively exercised.
- c. The test voltage shall be increased from the minimum to the selected test severity level, in order to determine any threshold of failure. The final severity level should not exceed the product specification value in order to avoid damage to the equipment.
- d. The test shall be performed with both air discharge and contact discharge. On reselected points at least 10 single discharges (in the most sensitive polarity) shall be applied on air discharge. On reselected points at least 25 single discharges (in the most sensitive polarity) shall be applied on contact discharge.
- e. For the time interval between successive single discharges an initial value of one second is recommended. Longer intervals may be necessary to determine whether a system failure has occurred.
- f. In the case of contact discharges, the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.
- g. In the case of painted surface covering a conducting substrate, the following procedure shall be adopted :
  - If the coating is not declared to be an insulating coating by the equipment manufacturer, then the pointed tip of the generator shall penetrate the coating so as to make contact with the conducting substrate.
  - Coating declared as insulating by the manufacturer shall only be submitted to the air discharge.
  - The contact discharge test shall not be applied to such surfaces.
- h. In the case of air discharges, the round discharge tip of the discharge electrode shall be approached as fast as possible (without causing mechanical damage) to touch the EUT . After each discharge, the ESD generator (discharge electrode) shall be removed from the EUT. The generator is then retriggered for a new single discharge. This procedure shall be repeated until the discharges are completed. In the case of an air discharge test, the discharge switch, which is used for contact discharge, shall be closed.

## 7.2. Test Setup for Tests Performed in Laboratory



The test setup consists of the test generator, EUT and auxiliary instrumentation necessary to perform DIRECT and INDIRECT application of discharges to the EUT as applicable, in the following manner :

- a. Contact Discharge to the conductive surfaces and to coupling plane;
- b. Air Discharge at insulating surfaces.

The preferred test method is that of type tests performed in laboratories and the only accepted method of demonstrating conformance with this standard. The EUT was arranged as closely as possible to arrangement in final installed conditions.

A ground reference plane was provided on the floor of the test site. It was a metallic sheet (copper or aluminum) of 0.25 mm, minimum thickness; other metallic may be used but they shall have at least 0.65 mm thickness. In the CerpPASS Technology Corp., we provided 1 mm thickness stainless steel ground reference plane. The minimum size of the ground reference plane is 2.5 m x 2.5 m, the exact size depending on the dimensions of the EUT. It was connected to the protective grounding system.

The EUT was arranged and connected according to its functional requirements. A distance of 1m minimum was provided between the EUT and the wall of the lab. and any other metallic structure. In cases where this length exceeds the length necessary to apply the discharges to the selected points, the excess length shall, where possible, be placed non-inductively off the ground reference plane and shall not come closer than 0.2m to other conductive parts in the test setup.

Where the EUT is installed on a metal table, the table was connected to the reference plane via a cable with a 470k ohm resistor located at each end, to prevent a build-up of charge. The test setup was consist a wooden table, 0.8m high, standing on the ground reference plane. A HCP, 1.6 m x 0.8 m, was placed on the table. The EUT and cables was isolated from the HCP by an insulating support 0.5 mm thick. The VCP size, 0.5 m x 0.5 m.



**7.3. Test Severity Levels**

Contact Discharge		Air Discharge	
Level	Test Voltage (KV) of Contact discharge	Level	Test Voltage (KV) of Air Discharge
1	±2	1	±2
2	±4	2	±4
3	±6	3	±8
4	±8	4	±15
X	Specified	X	Specified

Remark: "X" is an open level.

**7.4. Measurement Equipment**

Instrument	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date
ESD Simulator	Schaffner	NSG438	878	2010/06/15	2011/06/14

**7.5. Test Result and Data**

Final Test Result : **PASS**  
 Pass performance criteria : A  
 Required performance criteria : B  
 Basic Standard : IEC 61000-4-2  
 Product Standard : EN 55024  
 Test Voltage : ±2 / ±4 / ±8 KV for air discharge,  
 ±2 / ±4 KV for contact discharge  
 Temperature : 23°C  
 Relative Humidity : 55 %  
 Atmospheric Pressure : 1011 hPa  
 Test Date : Jun. 13, 2011



Test Mode: Mode 1

	Contact Discharge				Air Discharge					
	25 times / each				10 times / each					
Voltage	2 KV		4 KV		2 KV		4 KV		8 KV	
Point\Polarity	+	-	+	-	+	-	+	-	+	-
HCP	A	A	A	A	---	---	---	---	---	---
VCP	A	A	A	A	---	---	---	---	---	---
Case	A	A	A	A	---	---	---	---	---	---
DC Jack	A	A	A	A	---	---	---	---	---	---
RJ45 Port	---	---	---	---	A	A	A	A	A	A

Note: "A" means the EUT function is normal working during the test.

Test Mode: Mode 2 ~ Mode 3

	Contact Discharge				Air Discharge					
	25 times / each				10 times / each					
Voltage	2 KV		4 KV		2 KV		4 KV		8 KV	
Point\Polarity	+	-	+	-	+	-	+	-	+	-
HCP	A	A	A	A	---	---	---	---	---	---
VCP	A	A	A	A	---	---	---	---	---	---
Case	A	A	A	A	---	---	---	---	---	---
RJ45 Port	---	---	---	---	A	A	A	A	A	A
RJ45 Port (POE)	---	---	---	---	A	A	A	A	A	A

Note: "A" means the EUT function is normal working during the test.

Test engineer: Dora



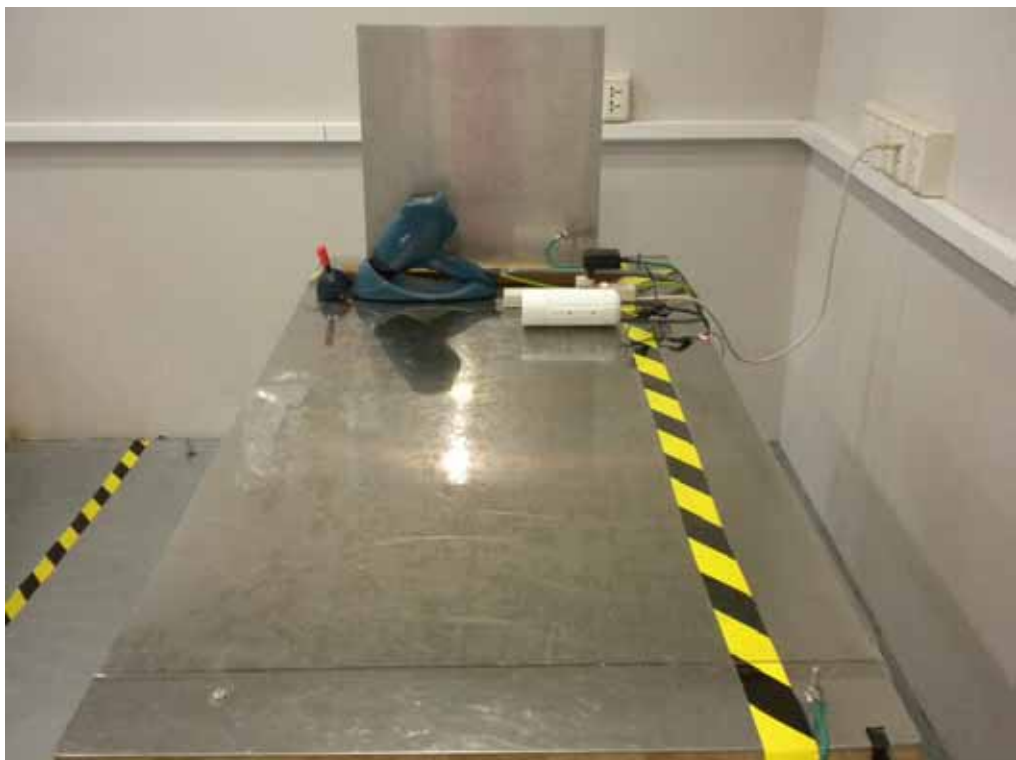
### 7.6. Test Photographs

Mode 1

Front View



Rear View





Mode 2

Front View



Rear View





Mode 3

Front View



Rear View





## 8. Radio Frequency electromagnetic field immunity test

### 8.1. Test Procedure

- The equipment to be tested is placed in the center of the enclosure on a wooden table. The equipment is then connected to power and signal leads according to pertinent installation instructions.
- The antenna which is enabling the complete frequency range of 80-1000 MHz is placed 3m away from the equipment. The required field strength is determined by placing the field strength meter(s) on top of or directly alongside the equipment under test and monitoring the field strength meter via a remote field strength indicator outside the enclosure while adjusting the continuous-wave to the applicable antennae.
- The test is normally performed with the antenna facing the most sensitive side of the EUT. The polarization of the field generated by the bucolical antenna necessitates testing each position twice, once with the antenna positioned vertically and again with the antenna positioned horizontally. The circular polarization of the field from the log-spiral antenna makes a change of position of the antenna unnecessary.
- At each of the above conditions, the frequency range is swept 80-1000 MHz, pausing to adjust the R.F. signal level or to switch oscillators and antenna. The rate of sweep is in the order of  $1.5 \times 10^{-3}$  decades/s. The sensitive frequencies or frequencies of dominant interest may be discretely analyzed.

### 8.2. Test Severity Levels

Frequency Band : 80-1000 MHz	
Level	Test field strength (V/m)
1	1
2	3
3	10
X	Specified
Remark: "X" is an open class.	

### 8.3. Measurement Equipment

Instrument	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date
Amplifiers 80-1000MHz/100W	SCHAFFNER	CBA9413B	43510	N/A	N/A
Amplifiers 80-3000MHz/20W	SCHAFFNER	CBA9428	43515	N/A	N/A
Antenna	SCHAFFNER	CBL6141A	4257	N/A	N/A
Power Meter	Boonton	4231A-01	115902	2010/11/30	2011/11/29
Field Probe	HOLADAY	HI-6005	00035824	2010/05/20	2011/05/19
Signal Generator	HP	8648C	3836U02289	2010/11/12	2011/11/11
Power Sensor	Boonton	51011-EMC	33312	2010/11/30	2011/11/29





8.4. Test Result and Data

Final Test Result : **PASS**  
 Pass performance criteria : A  
 Required performance criteria : A  
 Basic Standard : IEC 61000-4-3  
 Product Standard : EN 55024  
 Frequency Range : 80~1000 MHz  
 Temperature : 24°C  
 Relative Humidity : 55 %  
 Atmospheric Pressure : 1011 hPa  
 Test Date : Jun. 13, 2011

Test Mode: The test result of all test modes are the same

Modulation : AM 80% , 1KHz sine wave, Dwell time: 2.9 S				
Frequency Step Size : 1 % of preceding frequency value				
Frequency (MHz)	Antenna Polarization	face	Field strength (V/m)	Result
80~1000	Vertical	Front	3 V/m	A
80~1000	Vertical	Rear	3 V/m	A
80~1000	Vertical	Left	3 V/m	A
80~1000	Vertical	Right	3 V/m	A
80~1000	Horizontal	Front	3 V/m	A
80~1000	Horizontal	Rear	3 V/m	A
80~1000	Horizontal	Left	3 V/m	A
80~1000	Horizontal	Right	3 V/m	A

Note: "A" means the EUT function is normal working during the test.

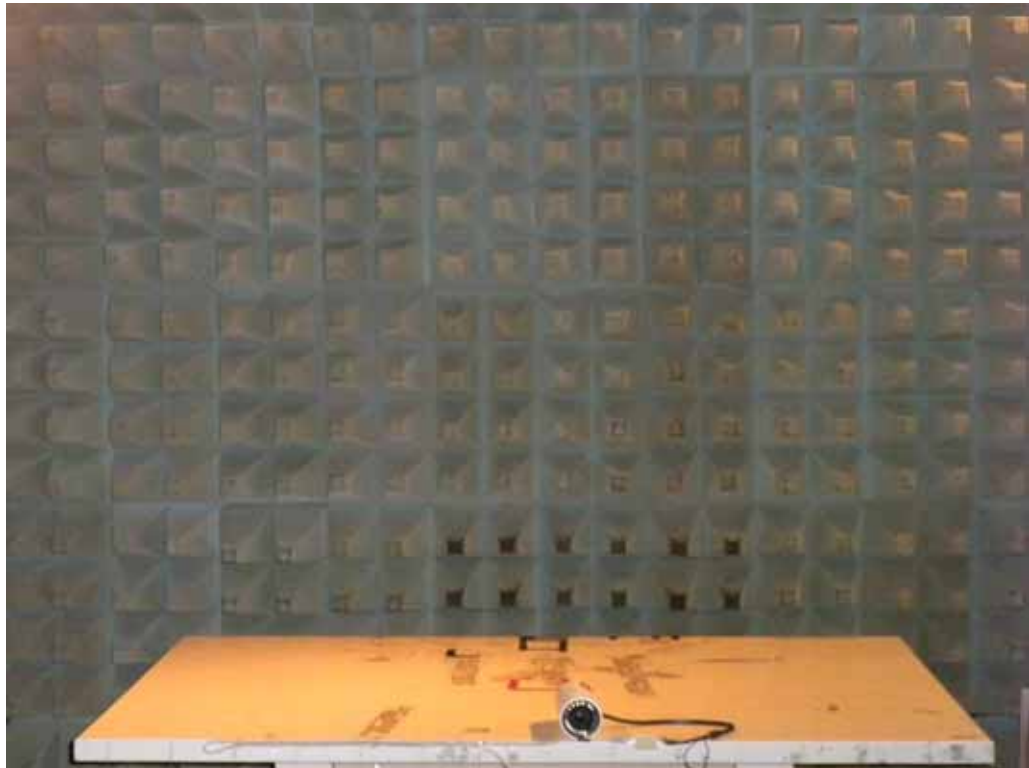
Test engineer: Dora



### 8.5. Test Photographs

Mode 1

Front View



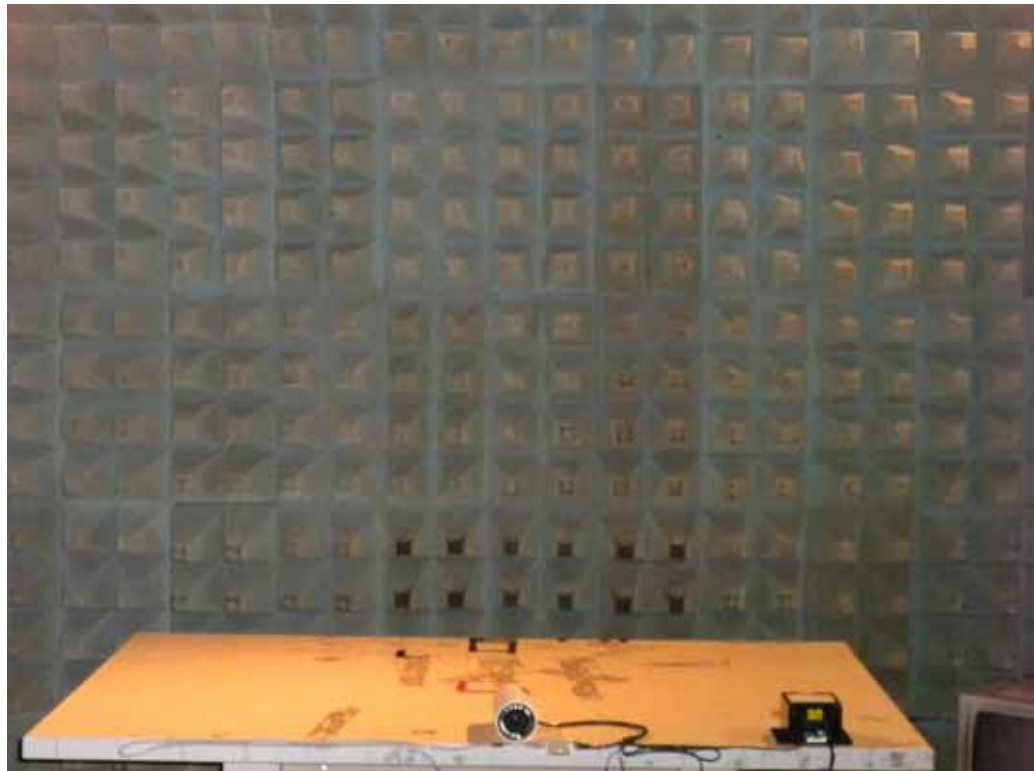
Rear View





Mode 2

Front View



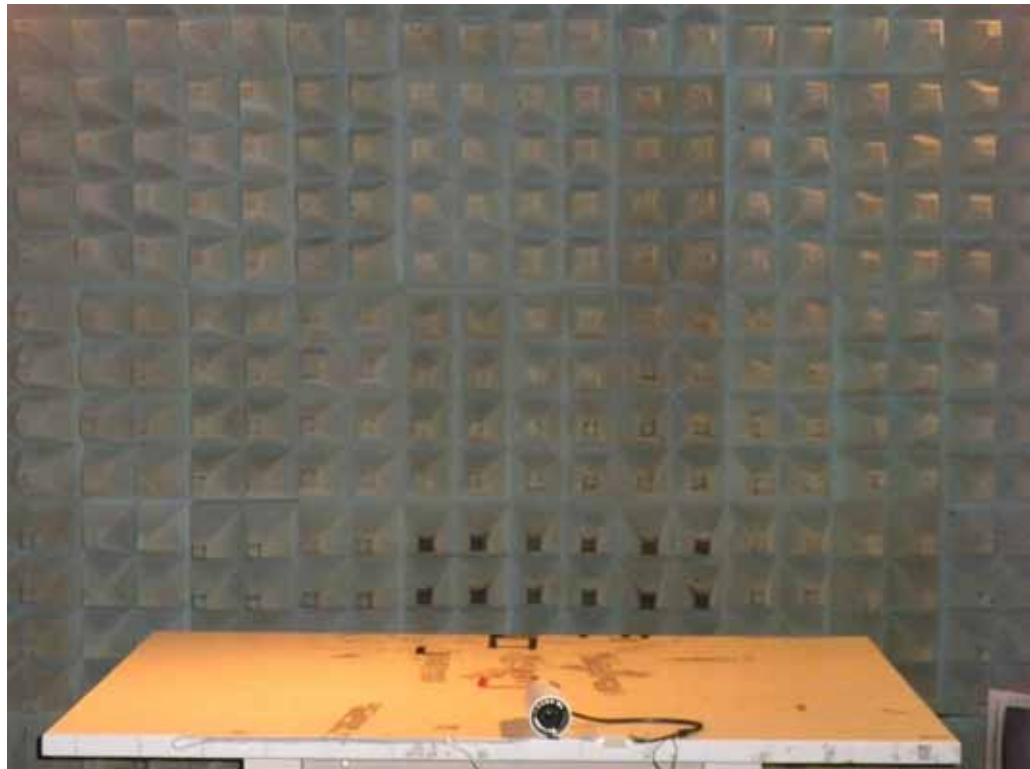
Rear View





Mode 3

Front View



Rear View





## 9. Electrical Fast Transient/ Burst Immunity Test

### 9.1. Test Procedure

- a. In order to minimize the effect of environmental parameters on test results, the climatic conditions when test is carrying out shall comply with the following requirements:
  - ambient temperature: 15 to 35 ;
  - relative humidity : 45% to 75%;
  - Atmospheric pressure: 86 Kpa (860 mbar) to 106 Kpa (1060 mbar).
- b. In order to minimize the effect of environmental parameters on test results, the electromagnetic environment of the laboratory shall not influence the test results.
- c. The variety and diversity of equipment and systems to be tested make it difficult to establish general criteria for the evaluation of the effects of fast transients/bursts on equipment and systems.
- d. Test on Power Line:
  - The EFT/B-generator was located on the GRP.. The length from the EFT/B-generator to the EUT is not exceeding 1 m.
  - The EFT/B-generator provides the ability to apply the test voltage in a non-symmetrical condition to the power supply input terminals of the EUT.
- e. Test on Communication Lines
  - The coupling clamp is composed of a clamp unit for housing the cable (length more than 3 m), and was placed on the GRP.
  - The coupling clamp provides the ability of coupling the fast transient/bursts to the cable under test.
- f. The test results may be classified on the basic of the operating conditions and the functional specification of the equipment under test, according to the following performance criteria :
  - Normal performance within the specification limits.
  - Temporary degradation or loss of function or performance which is self-recoverable.
  - Temporary degradation or loss of function or performance which requires operator intervention or system reset.
  - Degradation or loss of function which is not recoverable due to damage of equipment (components).

### 9.2. Test Severity Levels

The following test severity levels are recommended for the fast transient/burst test :

Open circuit output test voltage $\pm$ 10%		
Level	On Power Supply	On I/O signal, data and control line
1	0.5 KV	0.25 KV
2	1.0 KV	0.50 KV
3	2.0 KV	1.00 KV
4	4.0 KV	2.00 KV
X	Specified	Specified

Remark : “ X ” is an open level. The level is subject to negotiation between the user and manufacturer or is specified by the manufacturer.

### 9.3. Measurement Equipment

Instrument	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date
EMC Pro	KeyTek	EMC Pro	0309207	2011/03/24	2012/03/23



### 9.4. Test Result and Data

Final Test Result : **PASS**  
 Pass performance criteria : A  
 Required performance criteria : B  
 Basic Standard : IEC 61000-4-4  
 Product Standard : EN 55024  
 Test Voltage : On Power Supply -- ±0.5 KV, ±1.0 KV  
                               : On Signal Port -- ±0.5 KV  
 Temperature : 23°C  
 Relative Humidity : 55 %  
 Atmospheric Pressure : 1011 hPa  
 Test Date : Jun. 07, 2011

Test Mode: Mode 1

Pulse : 5/50 ns		Repetition Rate: <u>2.5 kHz</u> above 2.0 kV			
Burst : 15m/300ms		<u>5 kHz</u> below and equal 2.0Kv			
Test time : 1 min/each condition					
Voltage/ Mode/ Polarity/ Result/ Phase		<u>0.5 kV</u>		<u>1.0 kV</u>	
		+	-	+	-
Power Line	L	A	A	A	A
	N	A	A	A	A
	L-N	A	A	A	A
Signal Line	RJ45 (10M/ 100M/ 1G)	A	A	---	---

Note: "A" Means the EUT function is normal working during the test.

Test Mode: Mode 2

Pulse : 5/50 ns		Repetition Rate: <u>2.5 kHz</u> above 2.0 kV			
Burst : 15m/300ms		<u>5 kHz</u> below and equal 2.0Kv			
Test time : 1 min/each condition					
Voltage/ Mode/ Polarity/ Result/ Phase		<u>0.5 kV</u>		<u>1.0 kV</u>	
		+	-	+	-
Power Line	L	A	A	A	A
	N	A	A	A	A
	L-N	A	A	A	A
Signal Line	RJ45 (10M/ 100M/ 1G)	A	A	---	---

Note: "A" Means the EUT function is normal working during the test.



Test Mode: Mode 3

Pulse : 5/50 ns		Repetition Rate: <u>2.5 kHz</u> above 2.0 kV			
Burst : 15m/300ms		<u>5 kHz</u> below and equal 2.0Kv			
Test time : 1 min/each condition					
Voltage/ Mode/ Polarity/ Result/ Phase		<u>0.5 kV</u>		<u>1.0 kV</u>	
		+	-	+	-
Signal Line	RJ45 (POE)	A	A		

Note: "A" Means the EUT function is normal working during the test.

Test engineer: Yora



### 9.5. Test Photographs

Mode 1

Front View



Rear View







Clamp





Mode 2

Front View



Rear View





Clamp



Mode 3

Front View





## 10. Surge Immunity Test

### 10.1. Test Procedure

- a. Climatic conditions  
The climatic conditions shall comply with the following requirements :
  - ambient temperature : 15 to 35
  - relative humidity : 10 % to 75 %
  - atmospheric pressure : 86 kPa to 106 kPa ( 860 mbar to 1060 mbar )
- b. Electromagnetic conditions  
the electromagnetic environment of the laboratory shall not influence the test results.
- c. The test shall be performed according the test plan that shall specify the test set-up with
  - generator and other equipment utilized;
  - test level ( voltage/current );
  - generator source impedance;
  - internal or external generator trigger;
  - number of tests : at least five positive and five negative at the selected points;
  - repetition rate : maximum 1/min.
  - inputs and outputs to be tested;
  - representative operating conditions of the EUT;
  - sequence of application of the surge to the circuit;
  - phase angle in the case of AC. power supply;
  - actual installation conditions, for example :
    - AC : neutral earthed,
    - DC : ( + ) or ( - ) earthed to simulated the actual earthing conditions.
- d. If not otherwise specified the surges have to be applied synchronized to the voltage phase at the zero-crossing and the peak value of the AC. voltage wave ( positive and negative ).
- e. The surges have to be applied line to line and line(s) and earth. When testing line to earth, the test voltage has to be applied successively between each of the lines and earth, if there is no other specification.
- f. The test procedure shall also consider the non-linear current-voltage characteristics of the equipment under test. Therefore the test voltage has to be increased by steps up to the test level specified in the product standard or test plan.
- g. All lower levels including the selected test level shall be satisfied. For testing the secondary protection, the output voltage of the generator shall be increased up to the worst-case voltage breakdown level ( let-through level ) of the primary protection.
- h. If the actual operating signal sources are not available, that may be simulated. Under no circumstances may the test level exceed the product specification. The test shall be carried out according to a test plan.
- i. To find all critical points of the duty cycle of the equipment, a sufficient number of positive and negative test pulses shall be applied. For acceptance test previously unstressed equipment shall be used to the protection devices shall be replaced.

### 10.2. Test Severity Level

Level	Open-circuit test voltage, ± 10%, KV
1	0.5
2	1.0
3	2.0
4	4.0
X	Specified

NOTE: "X" is an open class. This level can be specified in the product specification.



### 10.3. Measurement Equipment

Instrument	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date
EMC Pro	KeyTek	EMC Pro	0309207	2011/03/24	2012/03/23

### 10.4. Test Result and Data

Final Test Result : **PASS**  
Pass performance criteria : A  
Required performance criteria : B  
Basic Standard : IEC 61000-4-5  
Product Standard : EN 55024  
Test Voltage : Input AC Power Port L-N --  $\pm 0.5$  kV,  $\pm 1.0$  kV  
Temperature : 24°C  
Relative Humidity : 52 %  
Atmospheric Pressure : 1011 hPa  
Test Date : Jun. 13, 2011

Test Mode: Mode 1 & Mode 2

#### Power Port

Waveform : 1.2/50 $\mu$ s(8/20 $\mu$ s)			Repetition rate : 60 sec		Time : 5 time/each condition	
Phase Voltage / Mode / Polarity / Result			0°	90°	180°	270°
0.5 kV, 1.0kV	L-N	+	A	A	A	A
		-	A	A	A	A

Note: "A" Means the EUT function is normal working during the test.

#### Signal Port

RJ45 where normal functioning cannot be achieved because of the impact of the CDN on the EUT.

Test engineer: 



### 10.5. Test Photographs

Mode 1

Front View



Rear View





Mode 2

Front View



Rear View





## 11. Conduction Disturbances induced by Radio-Frequency Fields

### 11.1. Test Procedure

- a. The EUT shall be operated within its intended climatic conditions. The temperature and relative humidity should be recorded.
- b. This test method test can be performed without using a sell shielded enclosure. This is because the disturbance levels applied and the geometry of the setups are not likely to radiated a high amount of energy, especially at the lower frequencies. If under certain circumstances the radiated energy is too high, a shielded enclosure has to be used.
- c. The test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn while the other non-excited RF-input ports of the coupling devices are terminated by a 50 ohm load resistor.
- d. The frequency range is swept from 150 KHz to 80 MHz, using the signal levels established during the setting process, and with the disturbance signal 80% amplitude modulated with a 1KHz sign wave, pausing to adjust the RF-signal level or to switch coupling devices as necessary. The rate of sweep shall no exceed  $1.5 \times 10^{-3}$  decades/s. Where the frequency is swept incrementally, the step size shall no exceed 1% of the start and thereafter 1% of the preceding frequency value.
- e. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies e.g. clock frequency (ies) and harmonics or frequencies of dominant interest shall be analyzed separately.
- f. An alternative test procedure may be adopted, wherein the frequency range is swept incrementally, with a step size not exceeding 4% of the start ad thereafter 4% of the preceding frequency value. The test level should be at least twice the value of the specified test level.
- g. In cases of dispute, the test procedure using a step size not exceeding 1% of the start and thereafter 1% of preceding frequency value shall take precedence.
- h. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.
- i. The use of special exercising programs is recommended.
- j. Testing shall be performed according to a Test Plan, which shall be included in the test report.
- k. It may be necessary to carry out some investigatory testing in order to establish some aspects of the test plan.

### 11.2. Test Severity Levels

Level	Voltage Level ( EMF )
1	1 V
2	3 V
3	10 V
x	Specified
NOTE - x is an open class. This level can be specified in the product specification.	

### 11.3. Measurement Equipment

Instrument	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date
CS GENERATOR	Schaffner	NSG 2070	1059	2010/10/06	2011/10/05
CDN (M2+M3)	Schaffner	M016	20056	2010/10/05	2011/10/04
CDN	Schaffner	T400	19818	2010/10/05	2011/10/04
EM-CLAMP	Schaffner	KEMZ 801	19793	2010/10/05	2011/10/04





**11.4. Test Result and Data**

- Final Test Result : **PASS**
- Pass performance criteria : A
- Required performance criteria : A
- Basic Standard : IEC 61000-4-6
- Product Standard : EN 55024
- Coupling mode : CDN-(M2) for AC power ports  
CDN-T400 for Signal Ports
- Temperature : 23°C
- Relative Humidity : 54 %
- Atmospheric Pressure : 1011 hPa
- Test Date : Jun. 07, 2011

Test Mode: Mode 1 & Mode 2

Frequency : 0.15~80MHz, Modulation : AM 80%, 1KHz sine wave, Dwell time: 2.9s Frequency Step Size : 1 % of preceding frequency value			
Frequency	Test Mode	Voltage(V)	Result
0.15 ~ 80MHz	Power(M2)	3	A
0.15 ~ 80MHz	RJ45 LAN (10M / 100M)	3	A
0.15 ~ 80MHz	Clamp LAN (1G)	3	A

Note: "A" Means the EUT function is normal working during the test.

Test Mode: Mode 3

Frequency : 0.15~80MHz, Modulation : AM 80%, 1KHz sine wave, Dwell time: 2.9s Frequency Step Size : 1 % of preceding frequency value			
Frequency	Test Mode	Voltage(V)	Result
0.15 ~ 80MHz	CLAMP (POE)	3	A

Note: "A" Means the EUT function is normal working during the test.

Test engineer:



### 11.5. Test Photographs

Mode 1

Front View



Rear View





Front View  
(Clamp)



Rear View  
(Clamp)





Mode 2

Front View



Rear View





Front View  
(Clamp)



Rear View  
(Clamp)





Mode 3

Front View

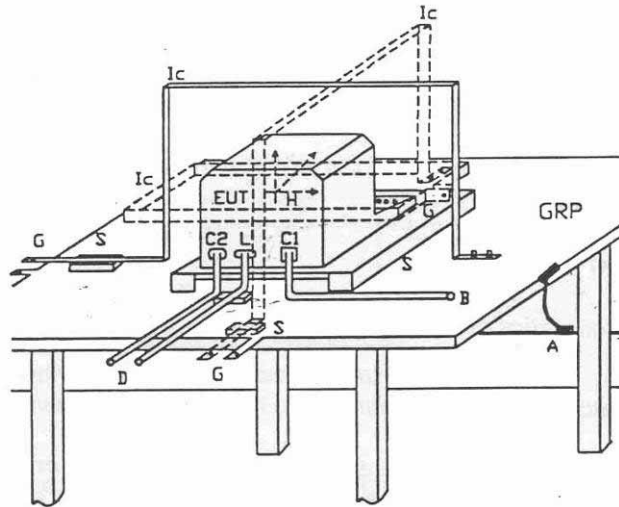


Rear View



## 12. Power Frequency Magnetic Field Immunity Test

### 12.1. Test Setup



- |     |                        |    |                               |
|-----|------------------------|----|-------------------------------|
| GPR | : Ground plane         | C1 | : Power supply circuit        |
| A   | : Safety earth         | C2 | : Signal circuit              |
| S   | : Insulating support   | L  | : Communication line          |
| EUT | : Equipment under test | B  | : To power supply source      |
| Lc  | : Induction coil       | D  | : To signal source, simulator |
| E   | : Earth terminal       | G  | : To the test generator       |

### 12.2. Test Severity Levels

Level	Magnetic field strength (A/m)
1	1
2	3
3	10
4	30
5	100
X <sup>1)</sup>	special

NOTE 1 "X" is an open level. This level can be given in the product specification.

### 12.3. Measurement Equipment

Instrument	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date
Magnetic Field Generator	KeyTek	F-1000-4-8-G -125A	N/A	2010/10/05	2011/10/04



12.4. Test Result and Data

Final Test Result : **PASS**  
 Pass performance criteria : A  
 Required performance criteria : A  
 Basic Standard : IEC 61000-4-8  
 Product Standard : EN 55024  
 Temperature : 24°C  
 Relative Humidity : 52 %  
 Atmospheric Pressure : 1011 hPa  
 Test Date : Jun. 07, 2011

Test Mode: The test result of all test modes are the same

Power Frequency Magnetic Field : <u>50</u> Hz, <u>1</u> A/m		
Coil Orientation	Testing duration	Results
X-axis	1.0 Min	A
Y-axis	1.0 Min	A
Z-axis	1.0 Min	A

Note: "A" Mean the EUT function is normal working during the test.

Test engineer: Yora





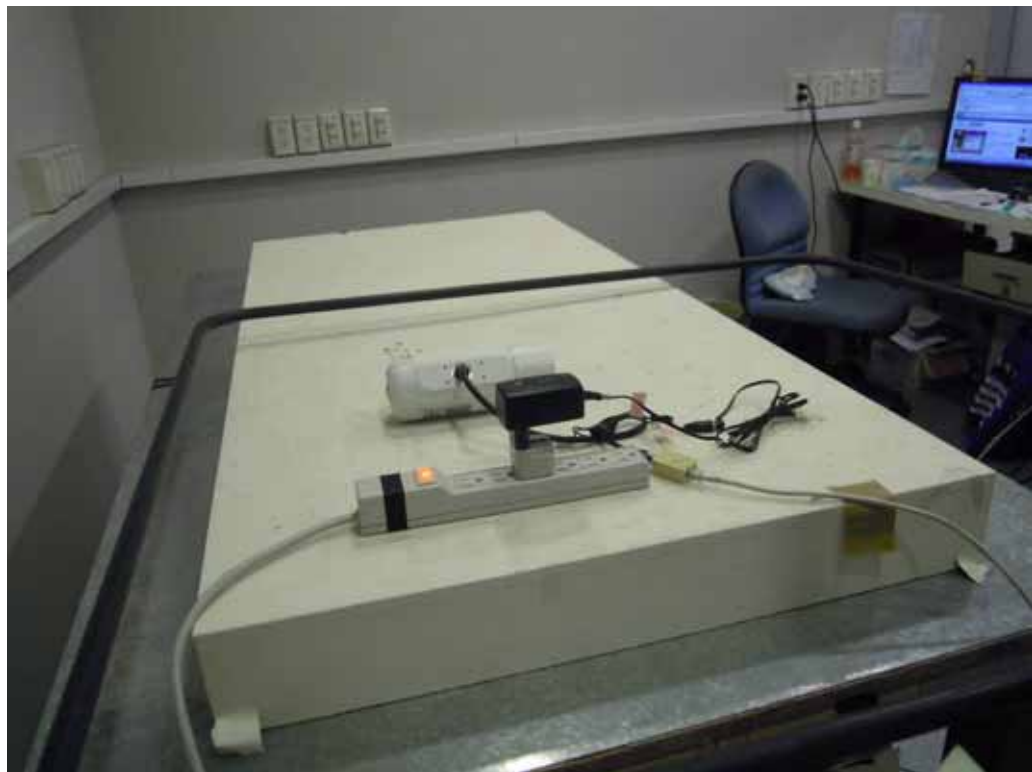
### 12.5. Test Photographs

Mode 1

Front View



Rear View





Mode 2

Front View



Rear View



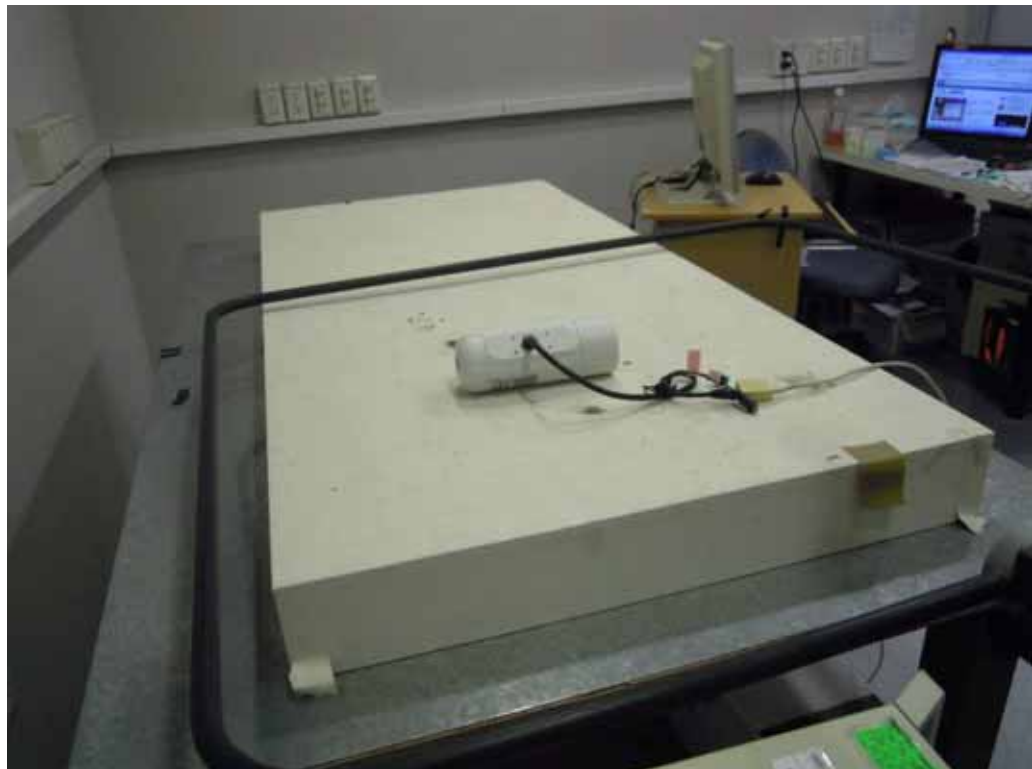


Mode 3

Front View



Rear View





## 13. Voltage Dips and Voltage Interruptions Immunity Test Setup

### 13.1. Test Conditions

1. Source voltage and frequency : 100/230/240V / 50Hz, Single phase.
2. Test of interval : 10 sec.
3. Level and duration : Sequence of 3 dips/interrupts.
4. Voltage rise (and fall) time : 1 ~ 5  $\mu$ s.
5. Test severity :

Voltage dips and Interrupt reduction (%)	Test Duration (period)
>95%	250
30%	25
>95%	0.5

### 13.2. Measurement Equipment

Instrument	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date
EMC Pro	KeyTek	EMC Pro	0309207	2011/03/24	2012/03/23



### 13.3. Test Result and Data

Final Test Result : **PASS**  
 Pass performance Criteria : B for voltage interruption, A for voltage dips  
 Required performance Criteria : C for voltage interruption, B/C for voltage dips  
 Basic Standard : IEC 61000-4-11  
 Product Standard : EN 55024  
 Temperature : 23°C  
 Relative Humidity : 55 %  
 Atmospheric Pressure : 1011 hPa  
 Test Date : Jun. 07, 2011

Test Mode: Mode 1

Voltage(UT): AC <u>230</u> V <u>50</u> Hz Interval(s) : <u>10s</u> Times : <u>3</u>				
Test mode	Test level reduction %	Durations (period)	Phase / Result	
			0°	180°
Voltage interruptions	>95%	250	B	B
Voltage dips	30%	25	A	A
	>95%	0.5	A	A

Note: "A" Means the EUT function is normal working during the test.

"B" Means the EUT function is affect during the test, but it can be recover automatically, after a while.

Test engineer: Dora



### 13.4. Test Photographs

Mode 1

Front View



Rear View





### Appendix A. Photographs of EUT









